

Precision BAW Oscillators for Low Power High Performance Applications

Danielle Griffith

Fellow

Texas Instruments

Dallas, Texas

danielle.griffith@ti.com

Tuesday 17th August 2021

About Danielle Griffith



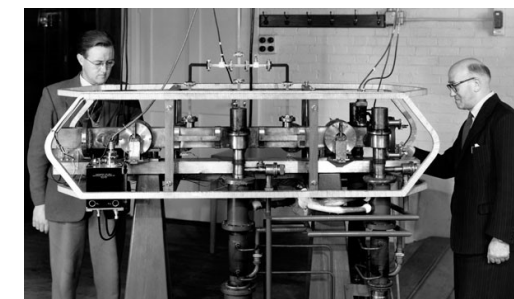
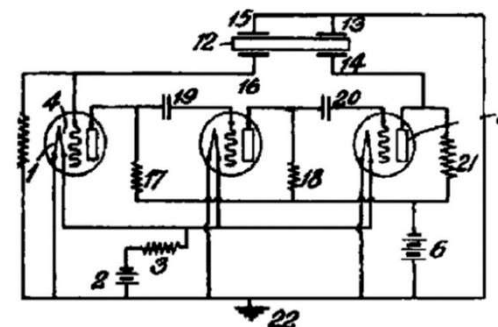
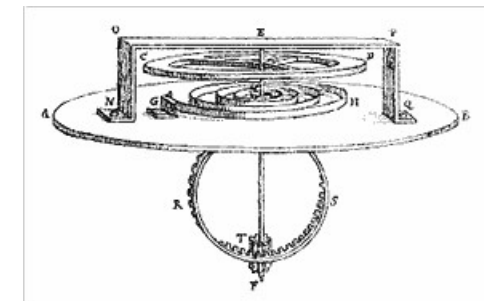
- 1996 & 1997 - B.S.E.E. and M.Eng degrees from the Massachusetts Institute of Technology, Cambridge
- 1997 - 2003 Motorola in Tempe, AZ - RF circuit design.
- 2003 - Current, Texas Instruments in Dallas
 - Fellow in the Connectivity business unit
 - Focusing on efficient wireless systems
- Distinguished contribution to SSCs Society
 - > 50 papers, multiple workshops, book chapter
 - Associate editor of the IEEE Journal of Solid-State Circuits
 - Technical Program Committees: RFIC ('14 - '15), ISSCC ('15 - '19), VLSI (from '19).
 - IEEE SSCS Distinguished Lecturer

Outline

- ❑ History of timekeeping
- ❑ Crystal oscillators and alternatives
- ❑ Bulk acoustic wave (BAW) resonators
- ❑ Architecture and design choices
- ❑ Measured performance
- ❑ System level advantages
- ❑ Applications
- ❑ Conclusions

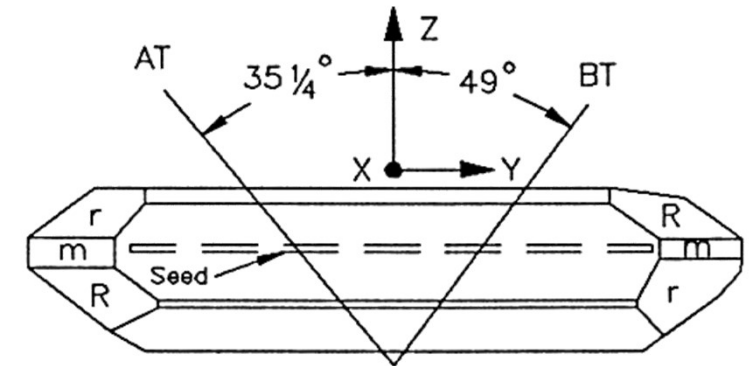
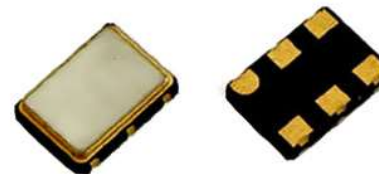
Brief History of Timekeeping

- ❑ Calendar: At least 5000 years ago
- ❑ Sundial: ~1500 BC
- ❑ Weight driven mechanical clock: 1283
- ❑ Balance spring/balance wheel: 1675 (Huygens, Hooke)
 - Accuracy ~10s/day
- ❑ Quartz crystal oscillator: 1921 (Cady)
 - Accuracy ~200s/year
- ❑ Atomic Clock: 1955 (Essen)
 - Today's accuracy ~30ns/year
- ❑ Now timing devices are a requirement for nearly all electronic systems
 - Key attributes: Operating frequency, frequency accuracy, frequency stability, power consumption, cost, size, environmental robustness

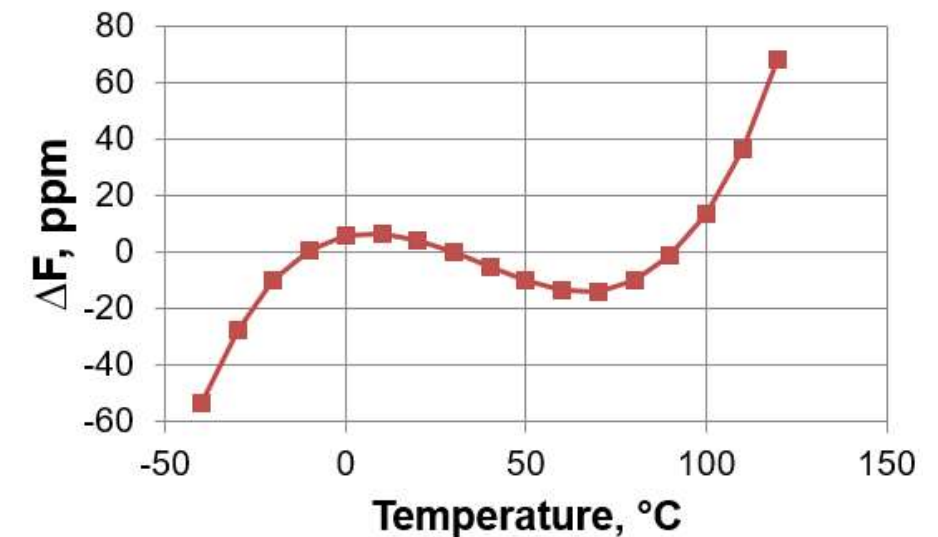


Quartz Crystal

- ❑ Quartz is a crystalline form of silicon dioxide
- ❑ Possible to cut a quartz crystal such that resonant frequency is quite stable over temperature ($\pm 40\text{ppm}$ from -40 to $+85^\circ\text{C}$).
- ❑ 10-50MHz crystals are often "AT" cut, giving a cubic (s-shape) curve of resonance frequency vs. temperature.
- ❑ A quartz crystal is specified as frequency X with capacitive load Y (e.g. 48MHz at $C_L=9\text{pF}$).
- ❑ Packaged size is often between $1.2 \times 1.0\text{mm}^2$ to $3.5 \times 2.5\text{mm}^2$.

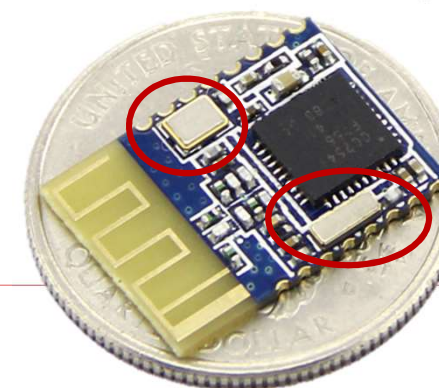
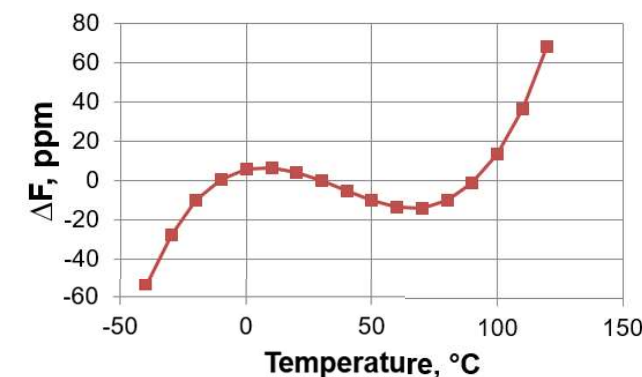
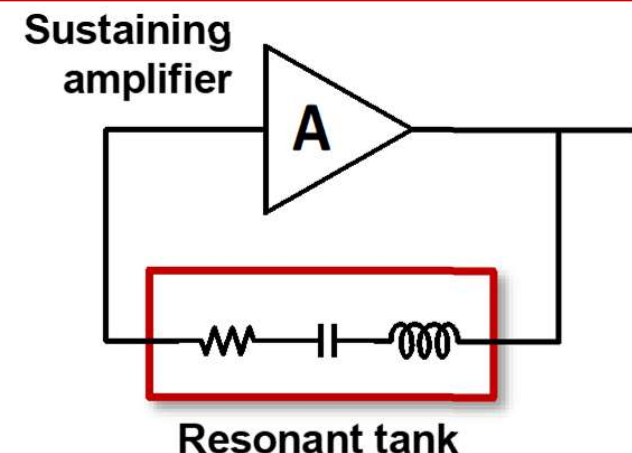


www.4timing.com



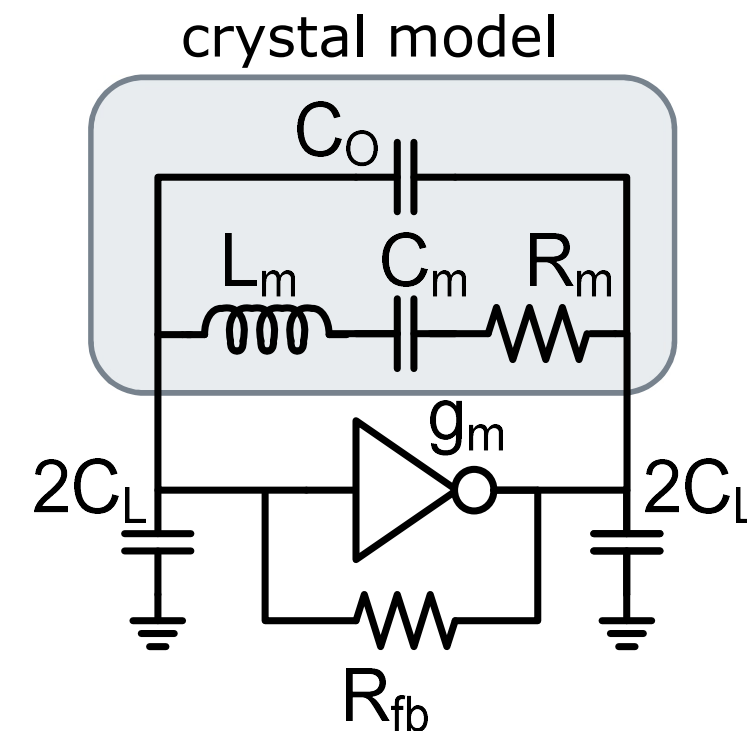
Crystal Oscillators

- ❑ Quartz crystal resonator + active circuitry = crystal oscillator
- ❑ Advantages
 - Mature technology (100 years old in 2021)
 - Quality Factor > 30,000: Low power consumption (~10 μ W/MHz)
 - Stable frequency – <100ppm (0.01%) variation -40°C to 85°C
- ❑ Disadvantages
 - Cost (equivalent to 1-2mm² of silicon)
 - Limits integration, size 2.0x1.6mm² is common
 - Degraded frequency stability at temperature extremes
 - Relatively slow startup time
 - Sensitivity to shock and vibration
 - Frequent supply issues (12-26 week lead time is common)



Frequency Accuracy & Quality Factor

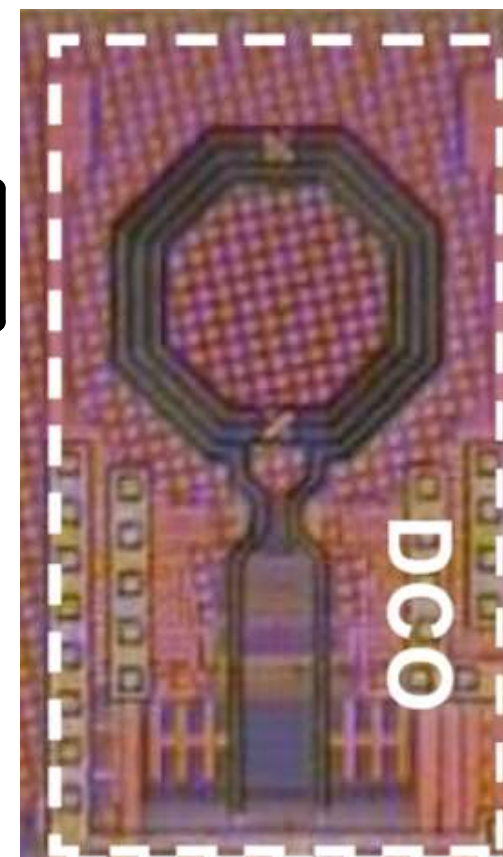
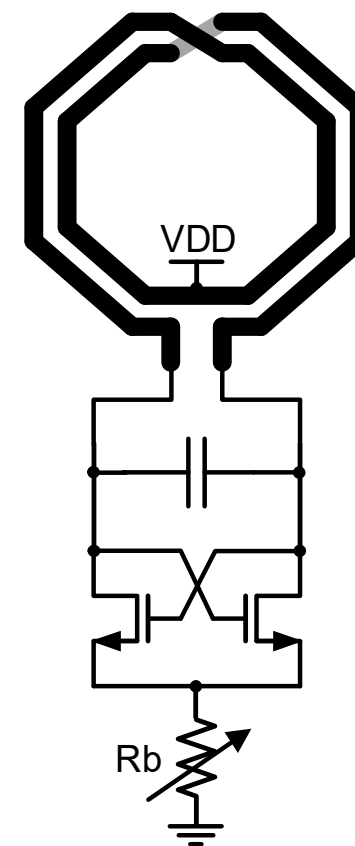
- Example frequency accuracy requirements for communications:
 - High speed USB $\pm 500\text{ppm}$
 - Bluetooth Low Energy $\pm 50\text{ppm}$
 - WiFi $\pm 20\text{ppm}$
- Higher Quality factor (Q) \rightarrow
 - better stability
 - lower noise/jitter
 - lower power consumption to sustain the oscillation
- Crystal Q > 30,000
 - Oscillator achieves $\sim \pm 40\text{ppm}$ frequency accuracy over wide temperature range with no active temperature compensation
 - Higher Q requires longer startup time. Startup energy can be limiting factor in duty-cycled applications



$$Q = \frac{1}{R_m} \sqrt{\frac{L_m}{C_m}}$$

Alternatives to Crystal Oscillators?

- ❑ Differential center tapped inductors can be fabricated in silicon
- ❑ Inductance determined by total length
- ❑ Q determined by diameter, metal and via resistance, and substrate loss
- ❑ On-chip inductor Q ~ 15
- ❑ Relatively large area required $\rightarrow 100 \times 100 \mu\text{m}$ to $500 \times 500 \mu\text{m}$
- ❑ Integrated oscillator has $> \pm 1\%$ frequency accuracy with no temperature compensation
- ❑ Challenging to implement compensation for 20x – 500x frequency stability improvement needed for communications



Microelectromechanical Systems (MEMS)

- Much higher Q possible than integrated planar inductors
 - 1000+ vs. ~15
 - Lower power oscillators with lower phase noise, better filters
- Examples:
 - SAW (Surface Acoustic Wave) resonator
 - BAW (Bulk Acoustic Wave) resonator
 - Used extensively in filters/duplexer products (20+ per phone)
- First BAW oscillator published >40 years ago
 - BAW oscillators not used in commercial products until 2019

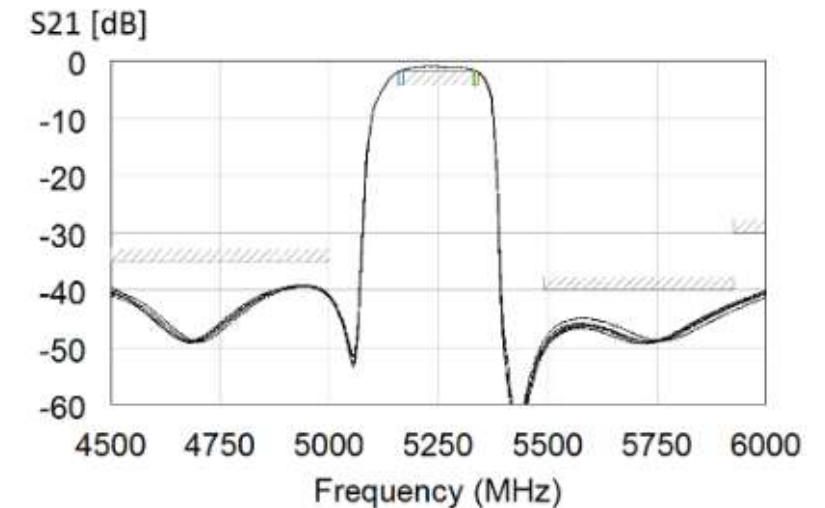


Figure 8: Passband insertion loss and nearby rejection of 5.25 GHz BAW filter.

Aigner,
2019

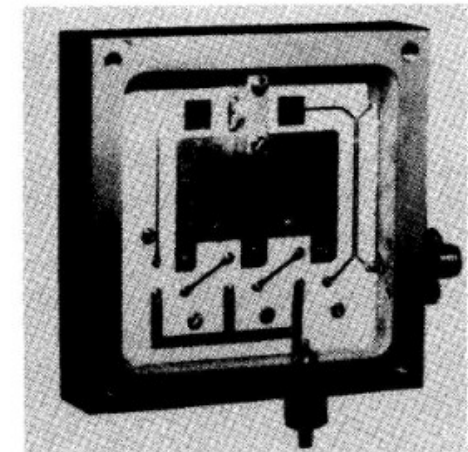
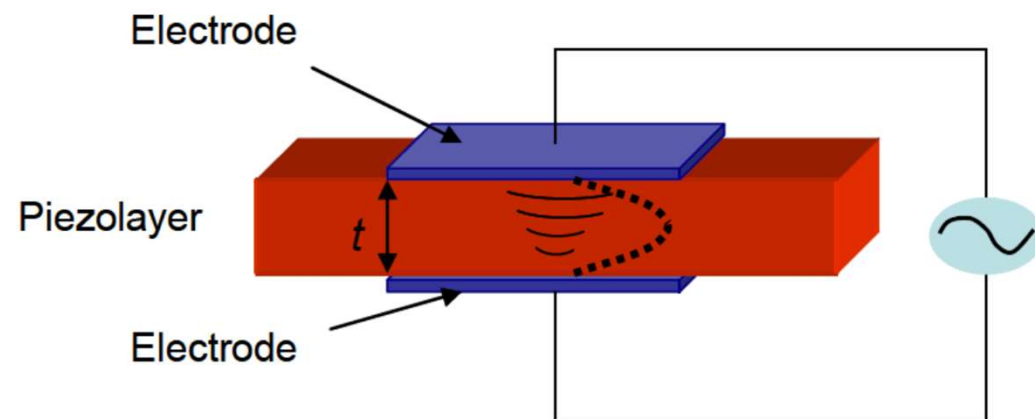


Fig. 6. Compact bulk-wave oscillator

"Behavior and Current Performances of SAW and BAW Oscillators" Schaer, 1976

Bulk Acoustic Wave (BAW) Resonator

- Passive device consisting of piezoelectric material surrounded by electrodes
 - Piezoelectric converts electrical ↔ mechanical energy
 - Mechanical resonant behavior in bulk of material, vs. SAW = Surface Acoustic Wave Resonator
- Aluminum Nitride (AlN) is the most commonly used thin film BAW resonator material

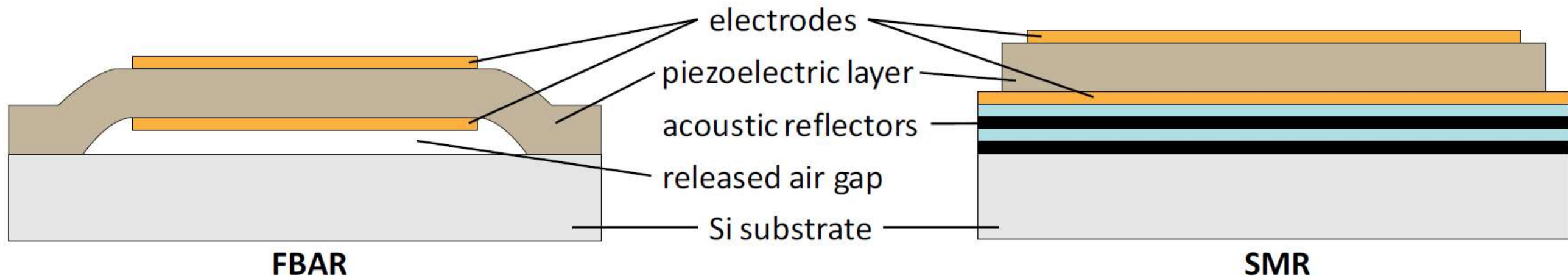


Resonant frequency, f_R dependent on AlN thickness, t , and acoustic velocity, v_L , to first order

$$f_R \approx \frac{v_L}{2t}$$

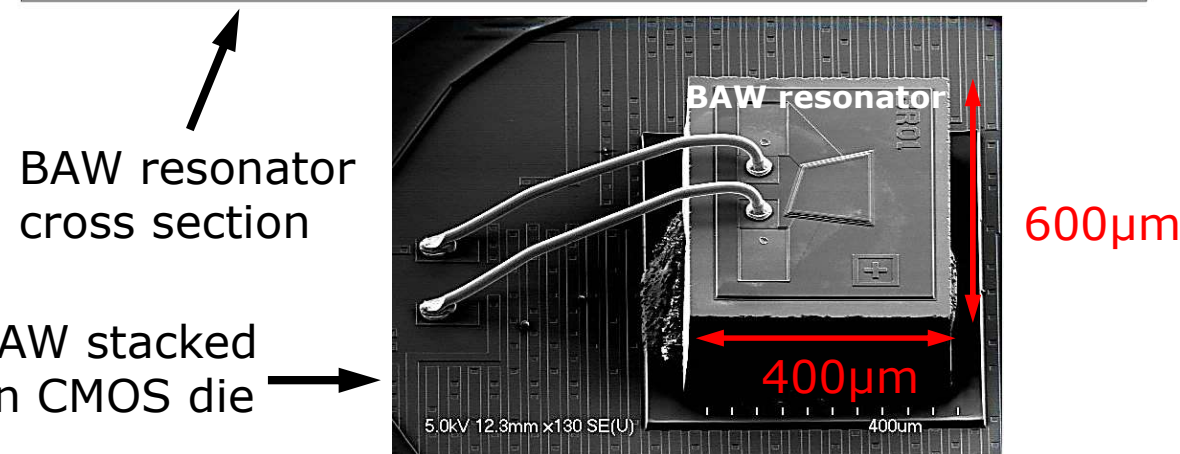
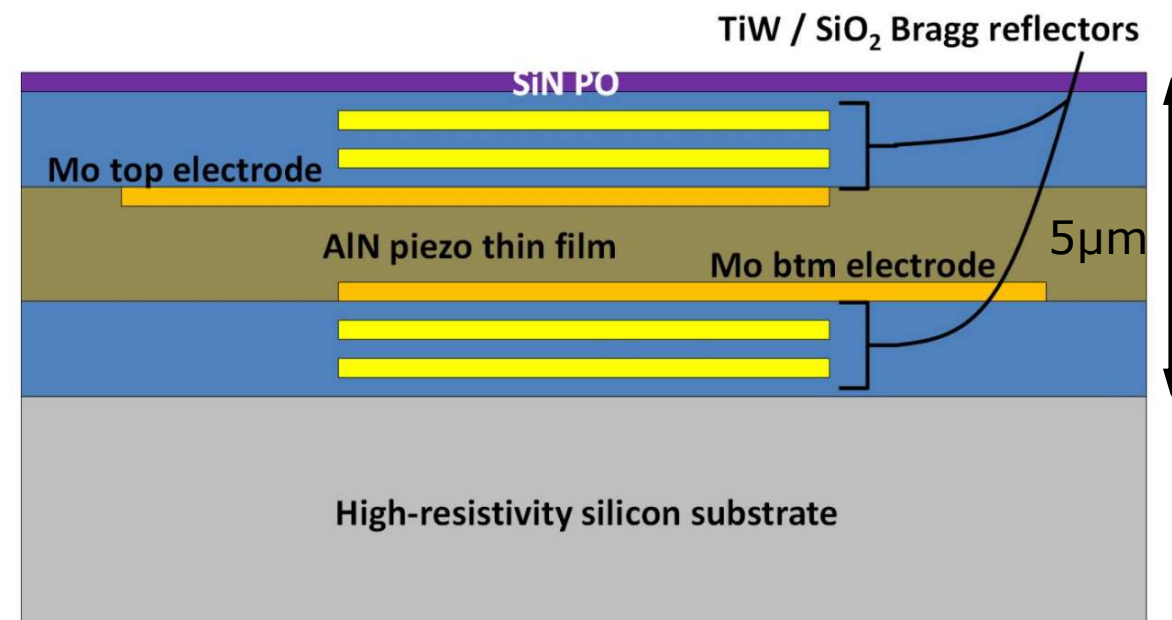
Types of BAW Resonators

- Two types of piezoelectric BAW resonators in the market before 2019:
 - Thin film bulk acoustic resonator (FBAR): Broadcom ACPF filter products
 - Solidly mounted resonator (SMR): Qorvo RF filter and duplexer products
- Cavities required on one or both sides of the resonator to provide acoustic isolation
 - May require hermetic packaging and increase sensitivity to external forces



Dual-Bragg BAW Resonator

- Dual-Bragg reflector structure
 - Alternating high- and low-acoustic impedance layers
 - Below the AlN piezoelectric film, reflector prevents energy from leaking into substrate → $Q > 1000$
 - Above the AlN, reflector prevents energy leaking into packaging material and device contamination → low frequency drift/aging
 - No vacuum cavities or hermetic packaging required → low cost
- ~5 μm thick on top of high-res Si substrate
- Shape optimized to reduce spurious modes

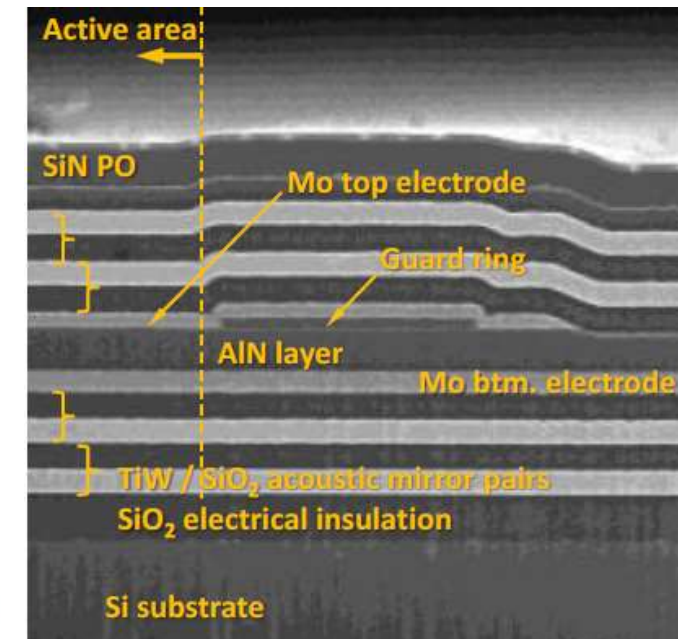
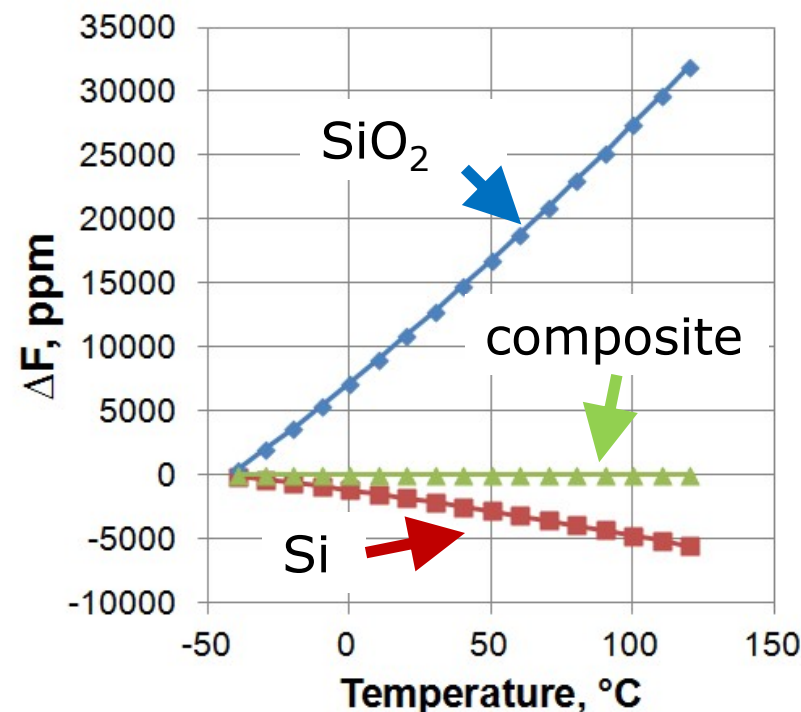


BAW resonator cross section

BAW stacked on CMOS die

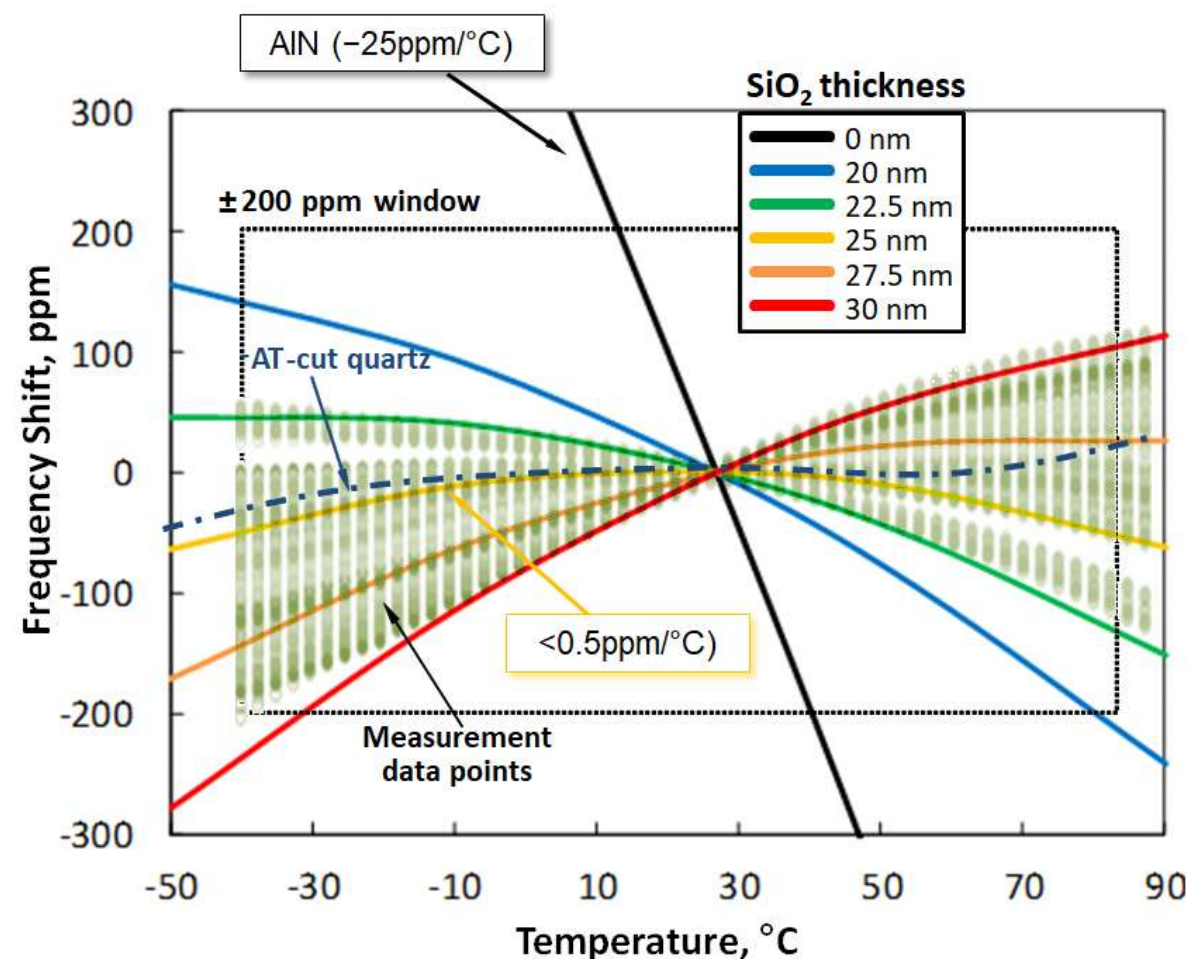
Passive Temperature Compensation

- Many materials used in MEMS resonators soften and expand as temperature increases
- Young's modulus is a measure of material stiffness
 - 180GPa for Si, -31ppm/°C, 70GPa for SiO₂, +180ppm/°C
- Passive compensation implemented by adding a material with a positive TC to the Si resonator structure.
 - Second order temperature coefficients remain.
- Compensation can degrade resonator quality factor
 - Increased power required to sustain the oscillation.



Passive Temperature Compensation

- First order temperature coefficient of frequency (TCF) for AlN is $-25\text{ppm}/^\circ\text{C}$.
 - More than 3000ppm frequency drift over industrial temperature range
- SiO_2 has positive TCF
 - Adding a SiO_2 layer reduces effective resonator TCF to as low as $\pm 0.5\text{ppm}/^\circ\text{C}$ (similar to AT-cut quartz crystals)
- Manufacturing tolerances of film thicknesses allow passive temperature compensation to within $<300\text{ppm}$ from -40 to 85°C
- Still not sufficient for all communications protocols

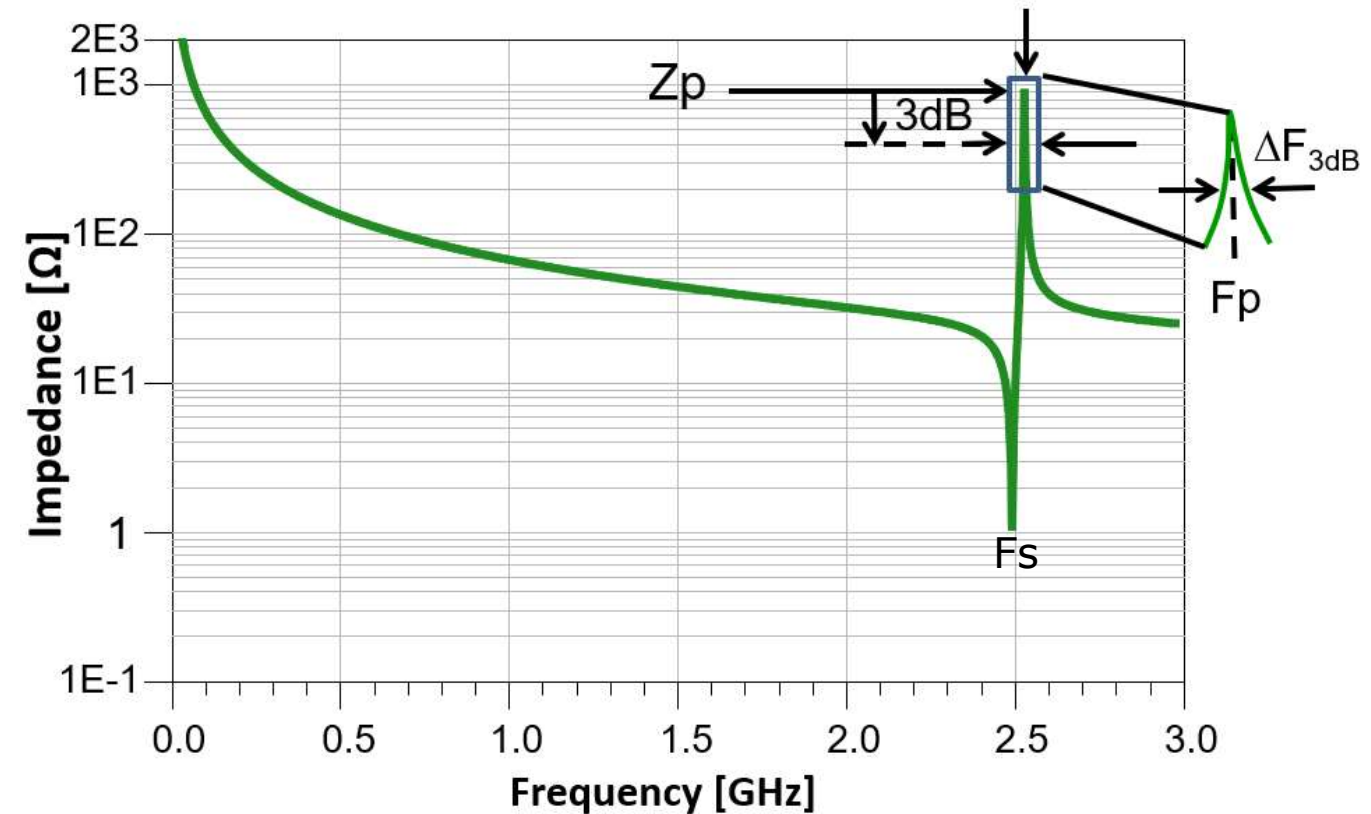
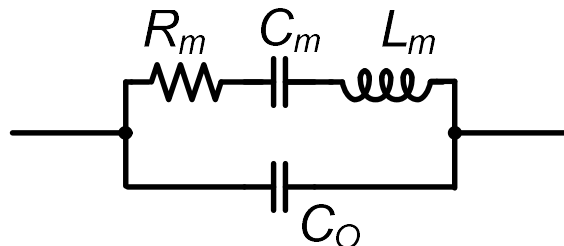


BAW Resonator Model

- Same model topology as quartz crystal
- Inductive between series and parallel resonance frequencies
- Two pins only
 - No ground
 - No bias voltage

Electrical Equivalent Model:

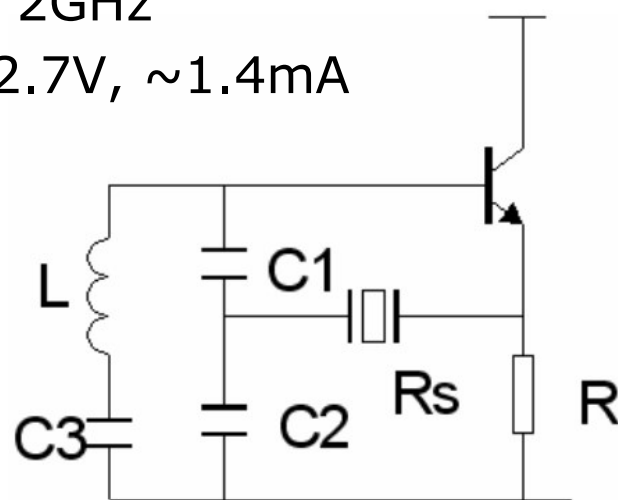
Modified Butterworth Van-Dyke (MBVD)



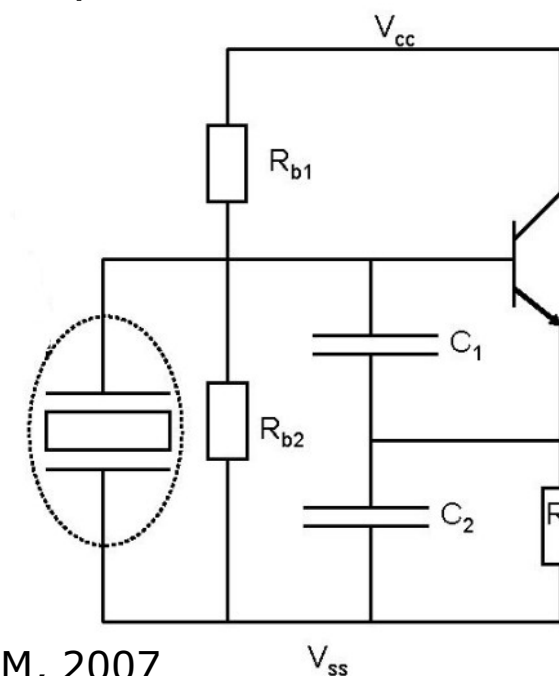
$$Q_p = \text{Quality Factor} = F_p / \Delta F_{3\text{dB}} > 1000$$

Single-Ended Oscillator Topologies

- ❑ Butler architecture
- ❑ BAW resonator and LC tank frequencies must be matched to within a few percent
- ❑ BAW passive temp compensation to $-5\text{ppm}/^\circ\text{C}$
- ❑ $Q=700$ at 2GHz
- ❑ BiCMOS, 2.7V, $\sim 1.4\text{mA}$
- ❑ Colpitts architecture
- ❑ Commonly used topology
- ❑ $\sim 600\text{ppm}$ frequency variation
- ❑ $Q=600$ at 2.1GHz
- ❑ BiCMOS $0.25\mu\text{m}$, 2.5V, $\sim 4.8\text{mA}$



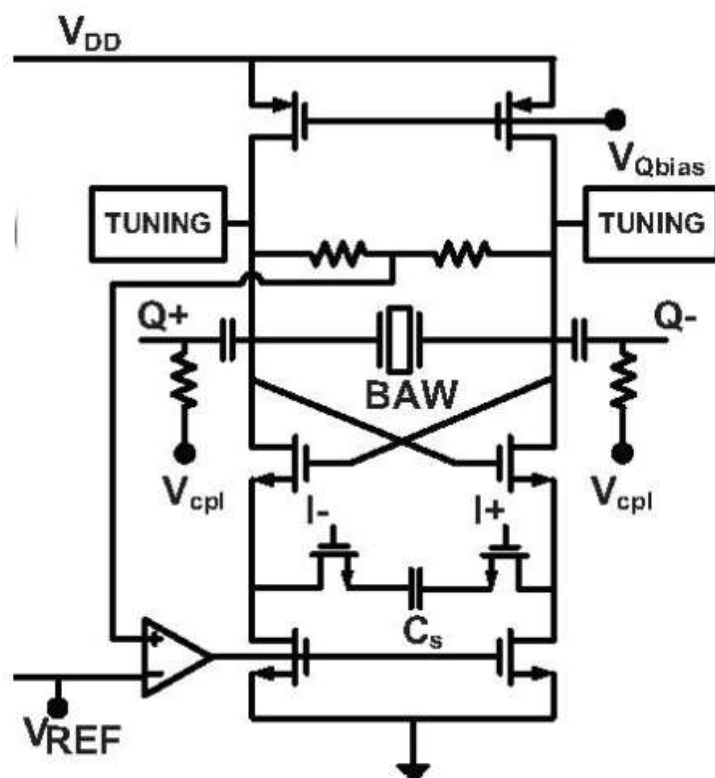
Vanhelmont, NXP, 2006



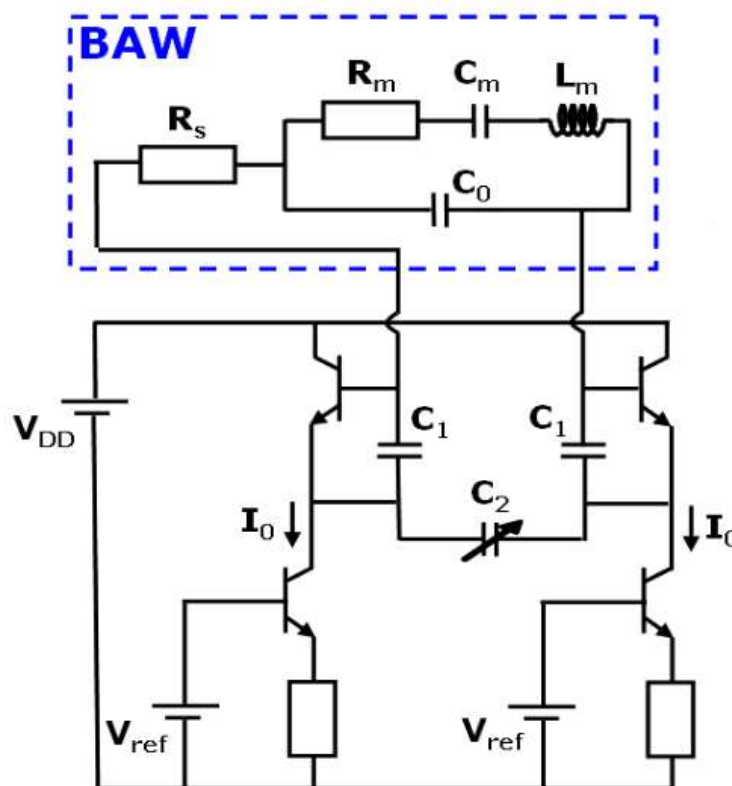
Razafimandimby, STM, 2007

Differential Topology Examples

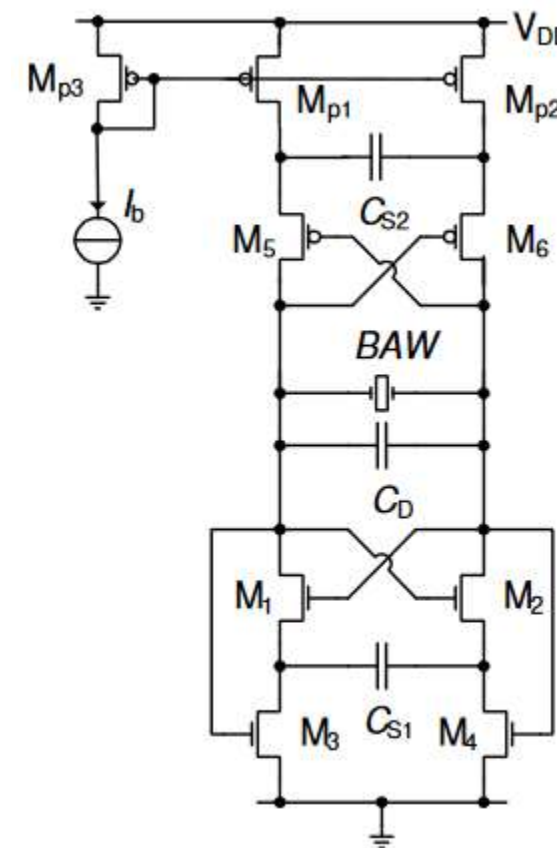
Differential
Rai, 2007
U. of Washington
2.1GHz, 600 μ A, 0.13 μ m CMOS



Differential Colpitts
Petit, 2009
STM
2.5GHz, 10mA, 0.25 μ m BiCMOS



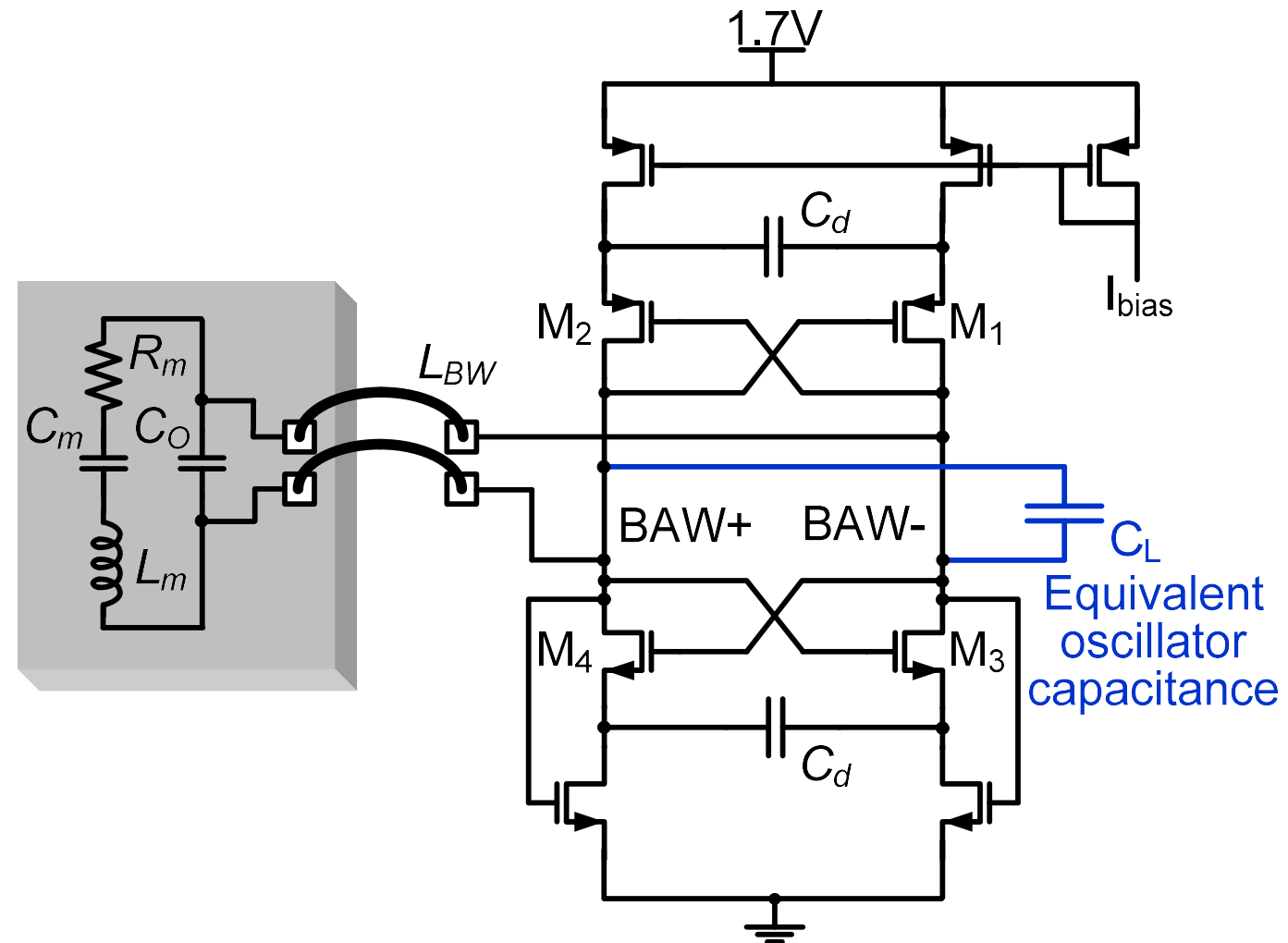
Complementary differential
Thirunarayanan, 2011
2.5GHz, 675 μ W, 0.18 μ m CMOS



Oscillator Design Constraints

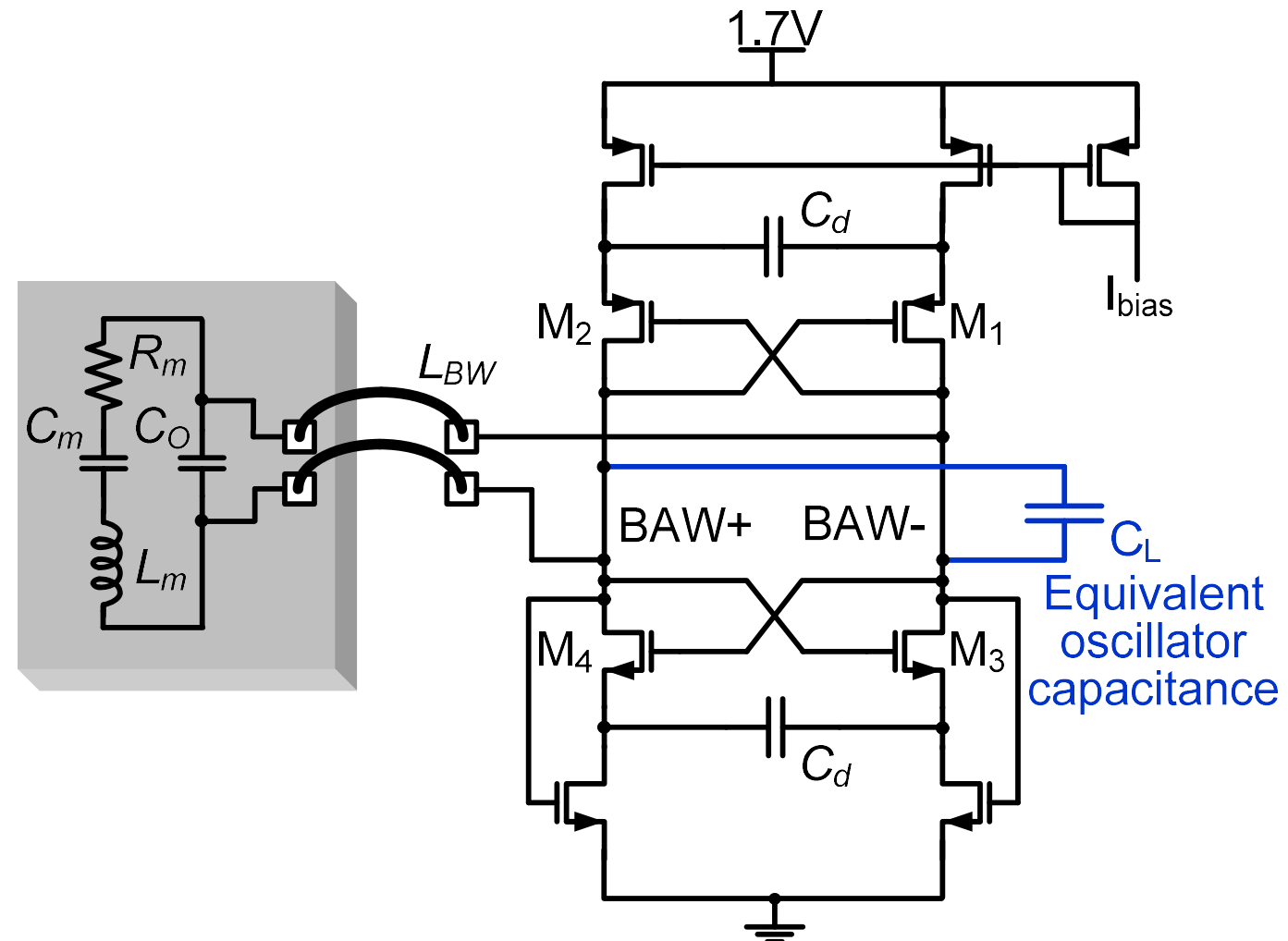
- ❑ BAW resonator stacked on and wire-bonded to CMOS die
- ❑ Four modes possible
 - Latched if C_d too small
 - Parasitic relaxation oscillation if $C_d > nC_L/2$ [Thirunarayanan, 2011]
 - Desired oscillation (2-3GHz)
 - Parasitic oscillation at f_B (5-8GHz)

$$f_B = \frac{1}{2\pi \sqrt{L_{BW} \left(\frac{C_L C_O}{C_L + C_O} \right)}}$$



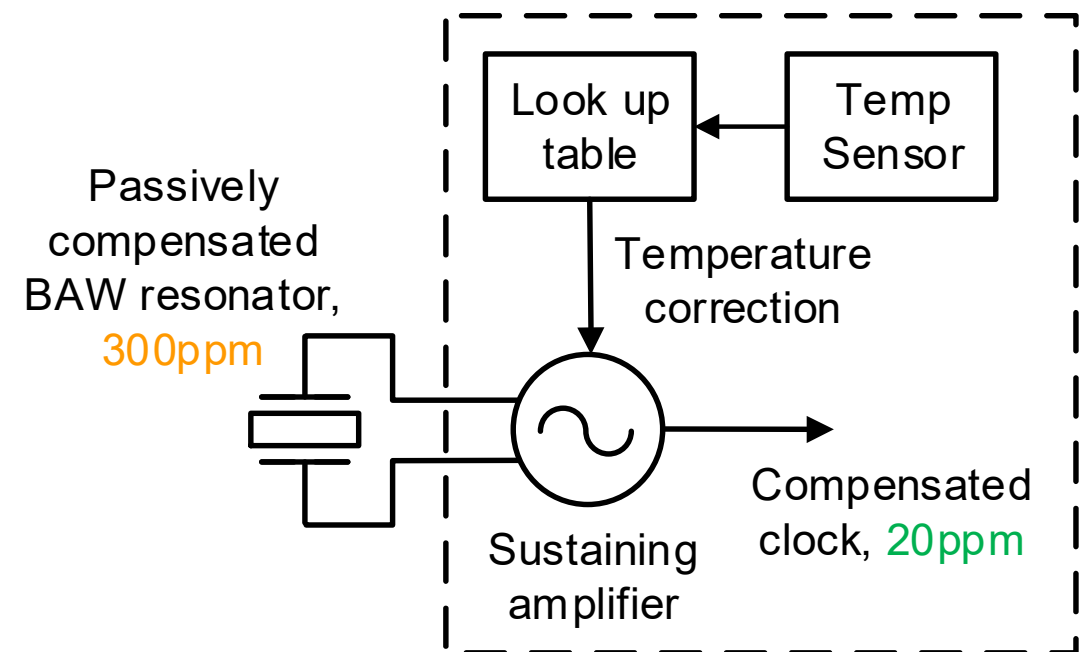
Avoid Parasitic Oscillation

- Bondwires short and spaced as closely as packaging rules allow
 - Mutual coupling \uparrow
LBW_effective \downarrow $f_B \uparrow$
 - Easier to ensure no gain at f_B
 - Flip chip packaging removes this mode
- M_1 - M_4 sized and biased to ensure no loop gain at parasitic oscillation frequencies
- Alternatively, LC trap used instead of C_d , at the cost of increased area

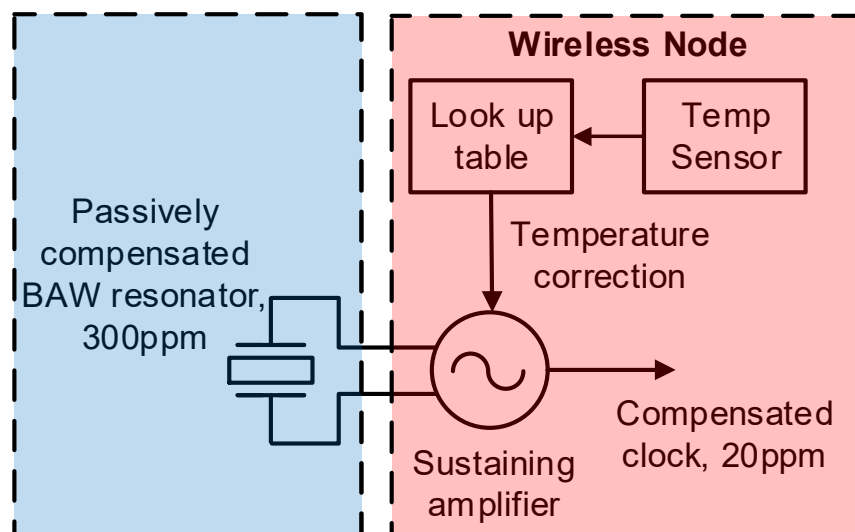


Active Temperature Compensation

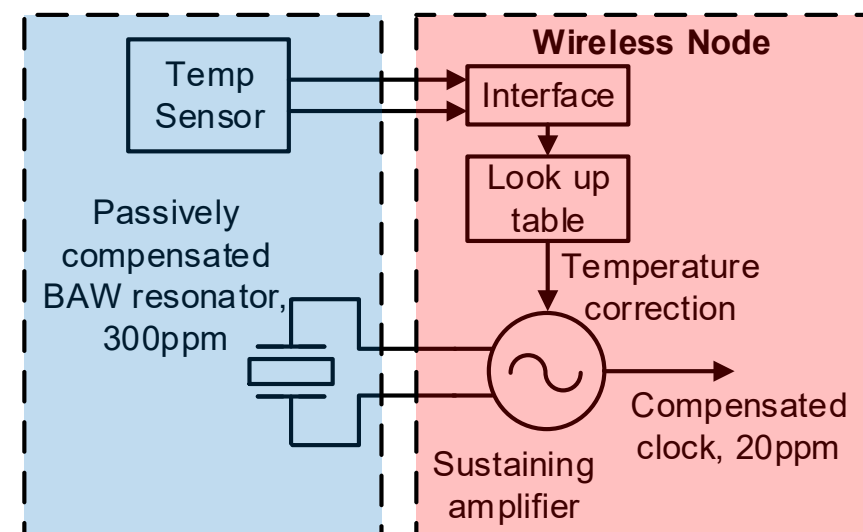
- ❑ Uncompensated BAW resonator: ΔF vs. T $\sim 3000\text{ppm}$ (0.3%)
- ❑ BAW resonator with passive temp. compensation: ΔF vs. T $\sim 300\text{ppm}$ (0.03%)
 - Still insufficient for many *wireless* communication applications
- ❑ BAW resonator with passive + active temp. compensation: ΔF vs. T $\sim 20\text{ppm}$
- ❑ Compensation limited by temperature sensor accuracy
- ❑ Compensation can be continuous or periodic



Temperature Sensor Location



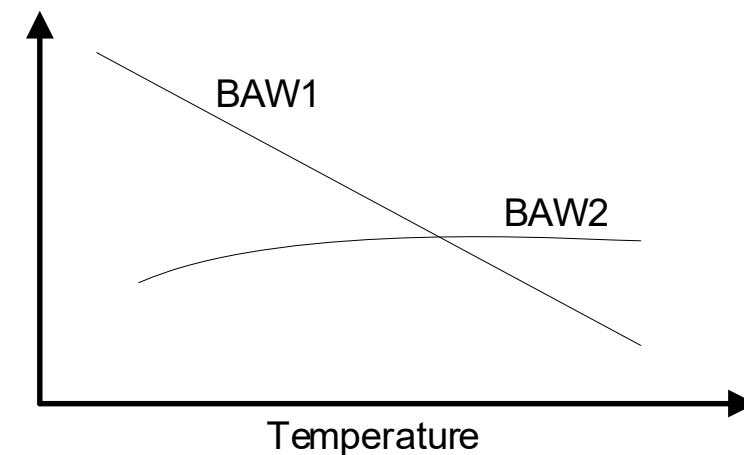
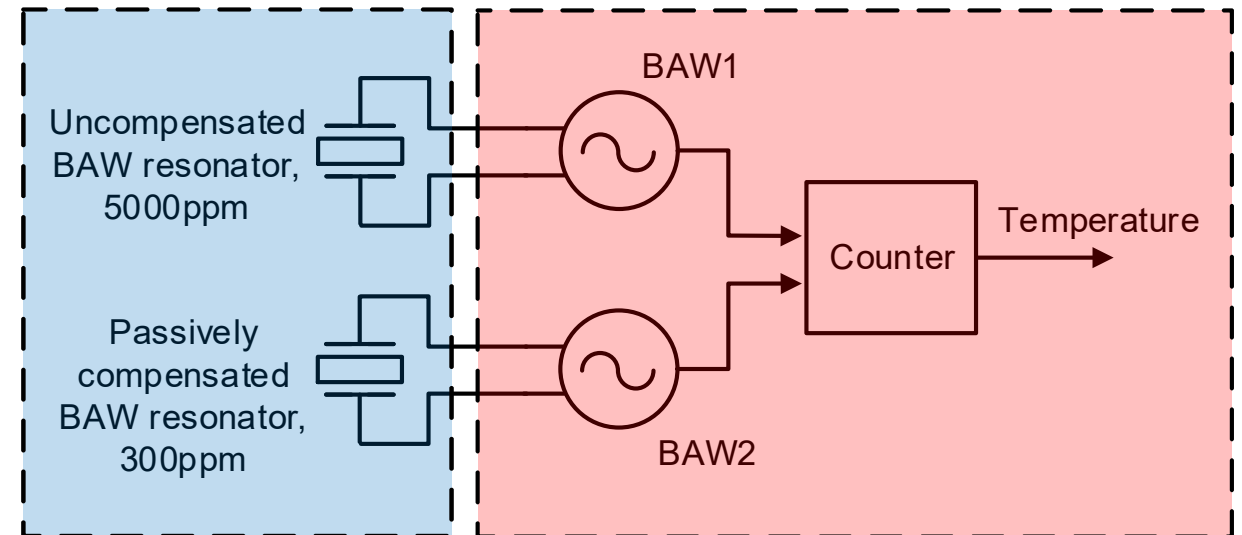
- Temperature sensor in die with active circuitry
 - Fewer bondwires
 - Smaller size for BAW resonator
 - Sensitive to temperature gradients between resonator and IC
 - Less accurate temperature measurement



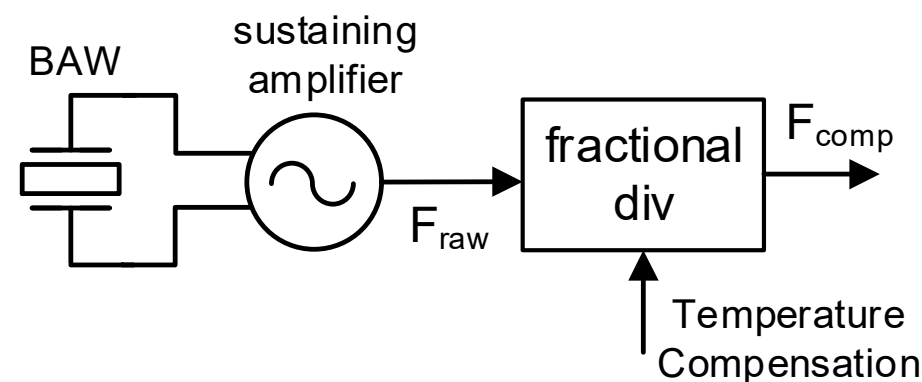
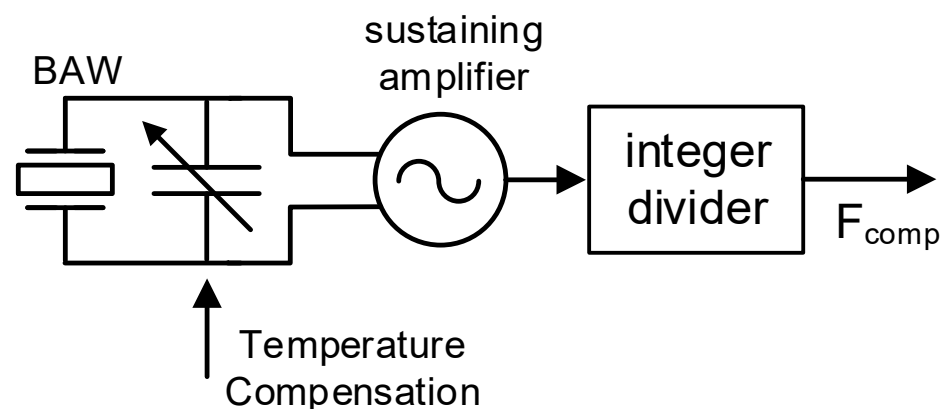
- Temperature sensor on BAW resonator die
 - 2 extra bondwires / connections
 - Larger size for BAW resonator
 - Interface required (ADC, oscillator)
 - Less sensitive to temperature gradients
 - More accurate temp measurement

BAW as a Temperature Sensor

- Two BAW oscillators used
 - BAW1 without passive temperature compensation layers
 - BAW2 passively compensated,
- Counter used to compare the relative frequency
- Temperature proportional to $\text{Freq}_{\text{BAW2}} - \text{Freq}_{\text{BAW1}}$
- Higher accuracy by allowing counter to measure over a longer time
- Initial offset calibration needed in production



Temperature Compensation



Advantages

- Lower complexity
- Low added jitter from divider

Disadvantages

- Lower tank $Q \rightarrow$ degraded phase noise
- Higher oscillator power consumption
- Parasitic resonance at a lower frequency
- Tuning range limited to $\sim 1\%$

Advantages

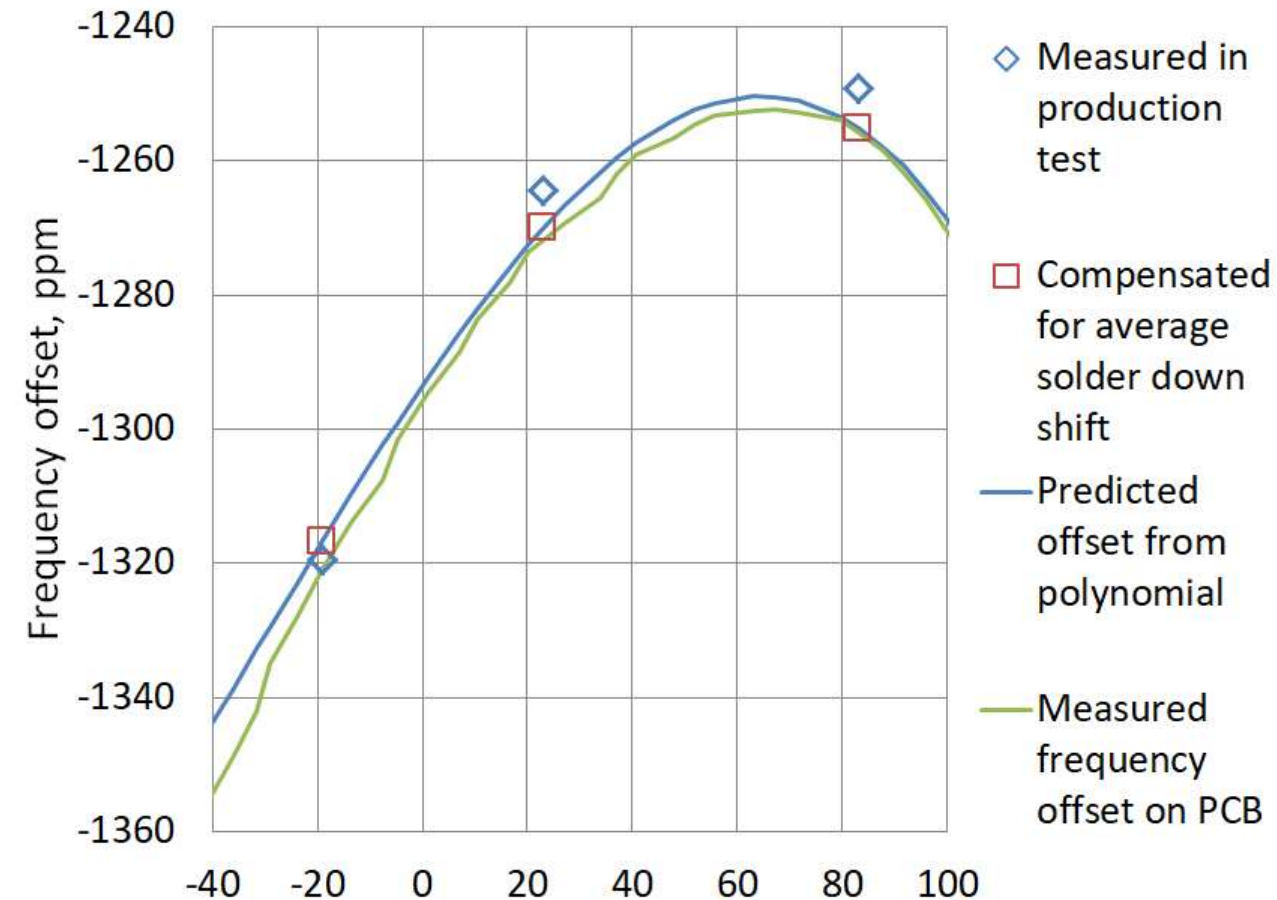
- Lowest oscillator power consumption
- Easy to avoid parasitic resonance (low cap)
- Wide tuning range

Disadvantages

- Constraints on divider resolution
- Extra area, complexity, and power for divider
- Added jitter from divider

Production Trimming

- Temp sensor output and BAW oscillation frequency measured at 3 temperatures during final test
 - Only resolution of temp sensor is important, not absolute accuracy
- Parabolic curve fit to these points stored to on-chip memory
 - TC2 is the curvature of the parabola
 - TC1 is the slope of the curve, <math><2\text{ppm}/^\circ\text{C}</math>
 - TC0 is the offset due to process variation, solder shift, and lifetime aging, <math><\pm 2000\text{ppm}</math>
- Interpolate any point on the curve for active temperature compensation

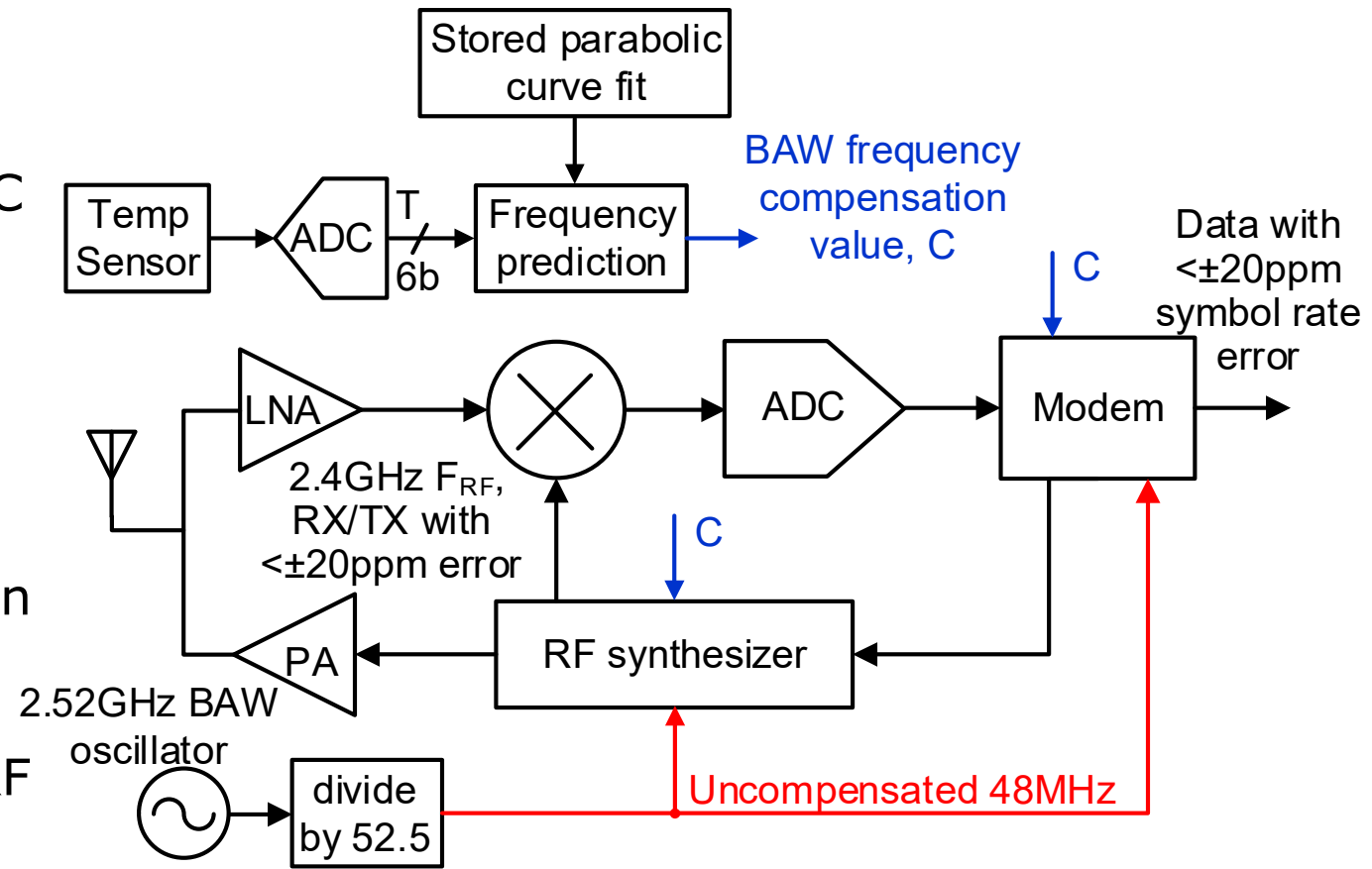


$$\frac{\Delta f}{f_0}(T) = TC_2(T - T_0)^2 + TC_1(T - T_0) + TC_0$$

Temperature sensor output °C

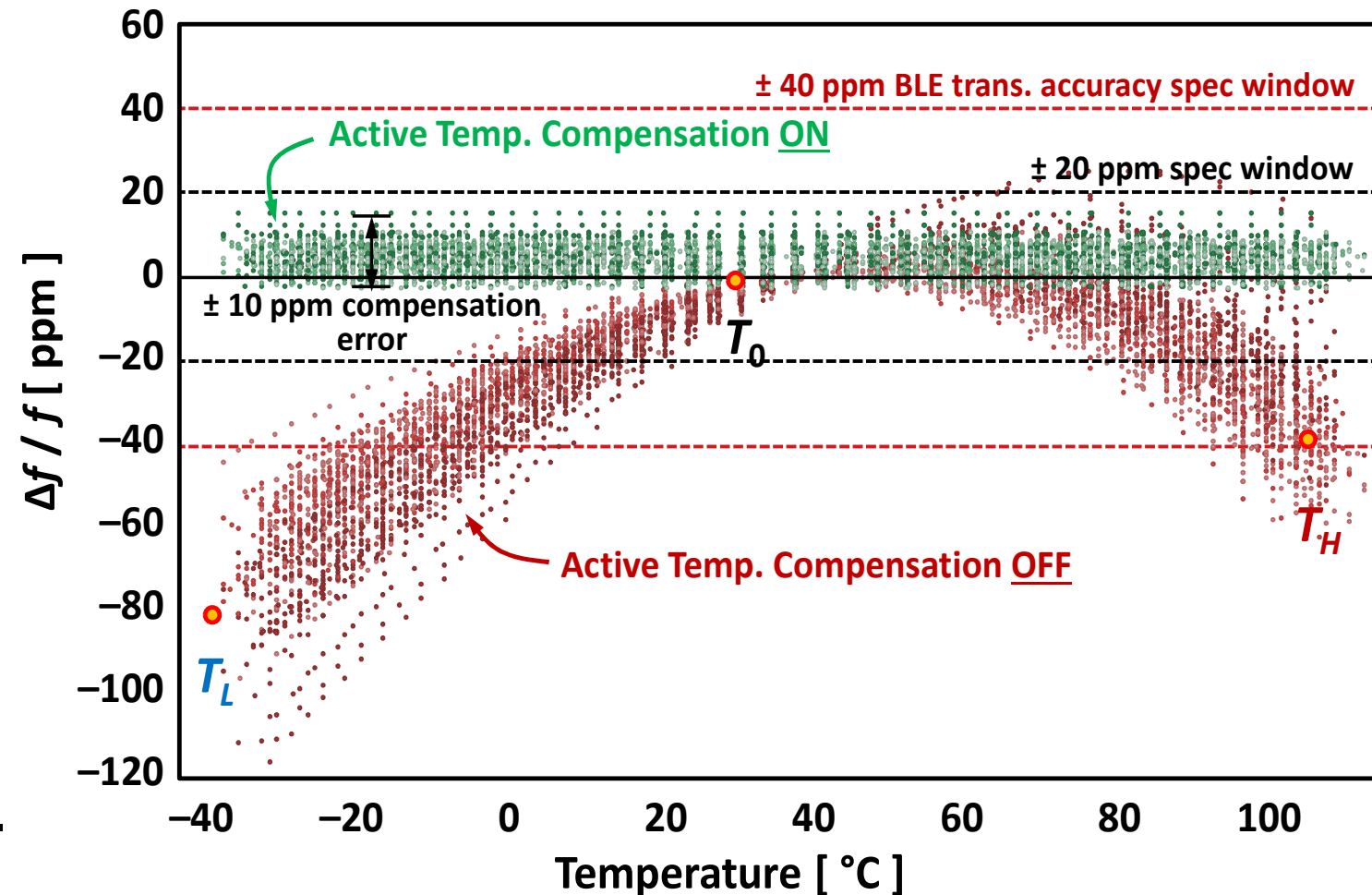
Active Temperature Compensation

- **Uncompensated clock** provided to SoC
 - 48MHz can vary $\pm 2000\text{ppm}$ at 25°C and 150ppm from -40 to 85°C
- **Frequency compensation value C** provided to modem & RF synthesizer
 - Output is a signed integer with 22 fractional bits $\rightarrow 0.25\text{ppm}$ resolution
 - $F_{REF} = 48\text{MHz} * \left(1 + \frac{C}{2^{22}}\right)$
 - RF synthesizer generates 2.4GHz RF with $< \pm 20\text{ppm}$ error
- New value for C applied when T changes by 4°C



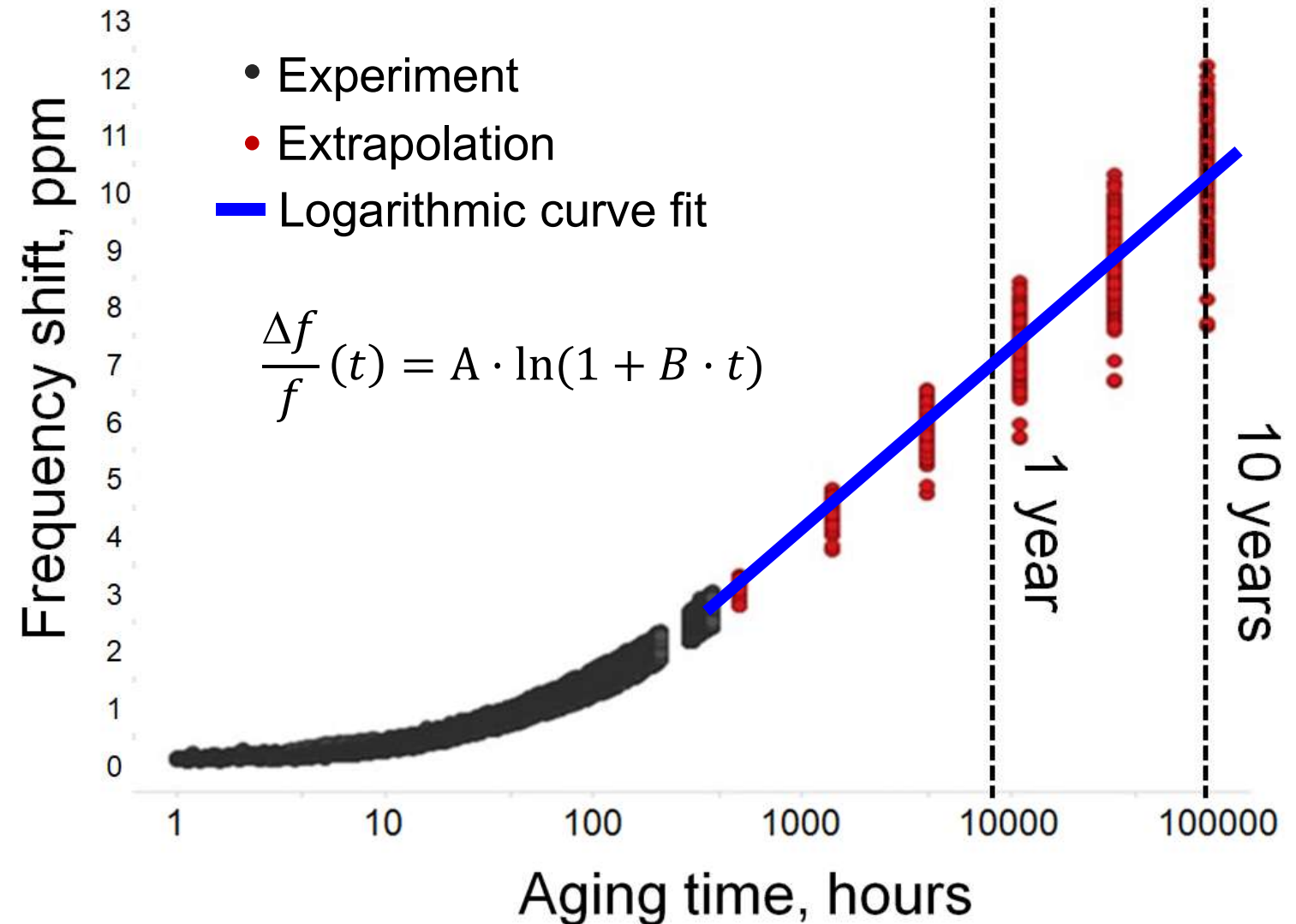
Active Temperature Compensation

- BAW oscillator frequency stability vs. temperature was measured at 2.4GHz at the RF synthesizer output for 80 devices
- **Red:** active temperature compensation disabled, passive temperature compensation in BAW resonator gives <math><150\text{ppm}</math>
- **Green:** active temperature compensation enabled, <math><\pm 10\text{ppm}</math> compensation error.



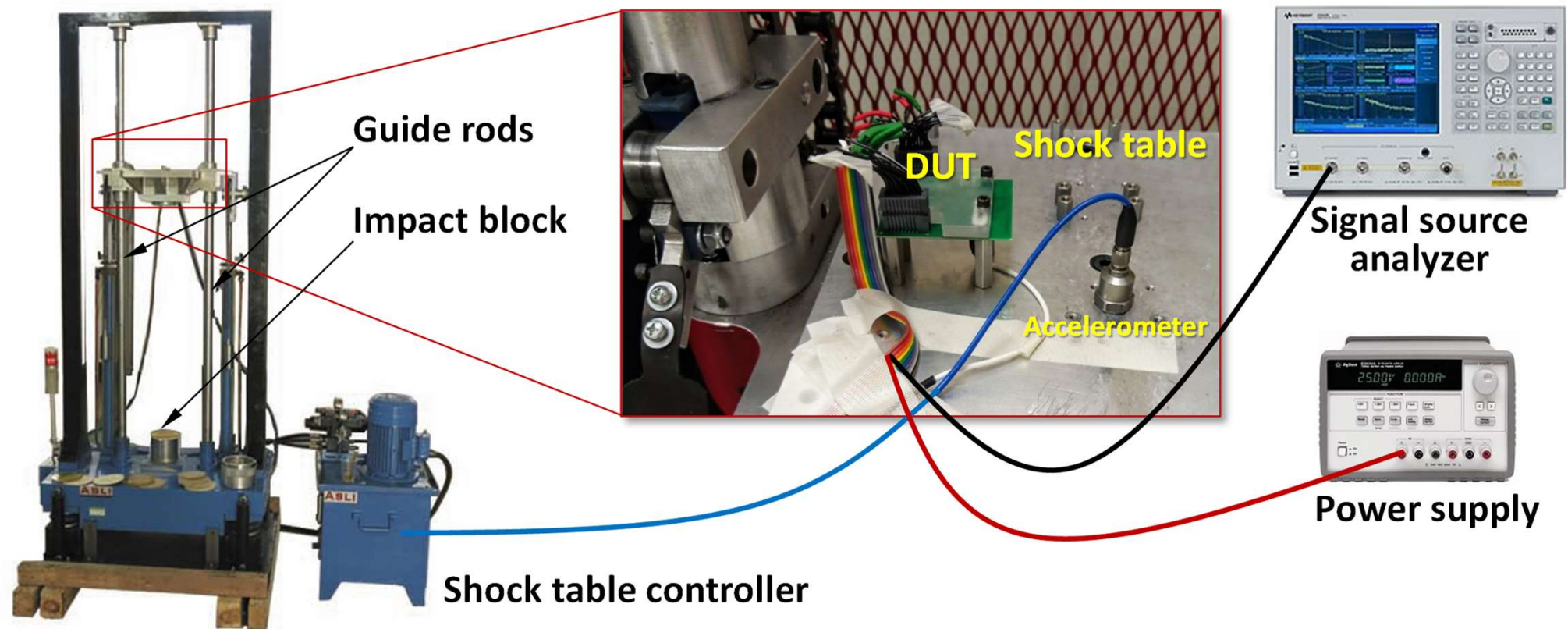
Active Aging & Frequency Drift

- Aging: the long-term oscillator frequency drift
- Oscillator operated continuously and frequency drift measured
- Logarithmic aging observed due to slight resonator stress relaxation
- Aging extrapolated to 10 years is 7 to 12ppm for these devices.



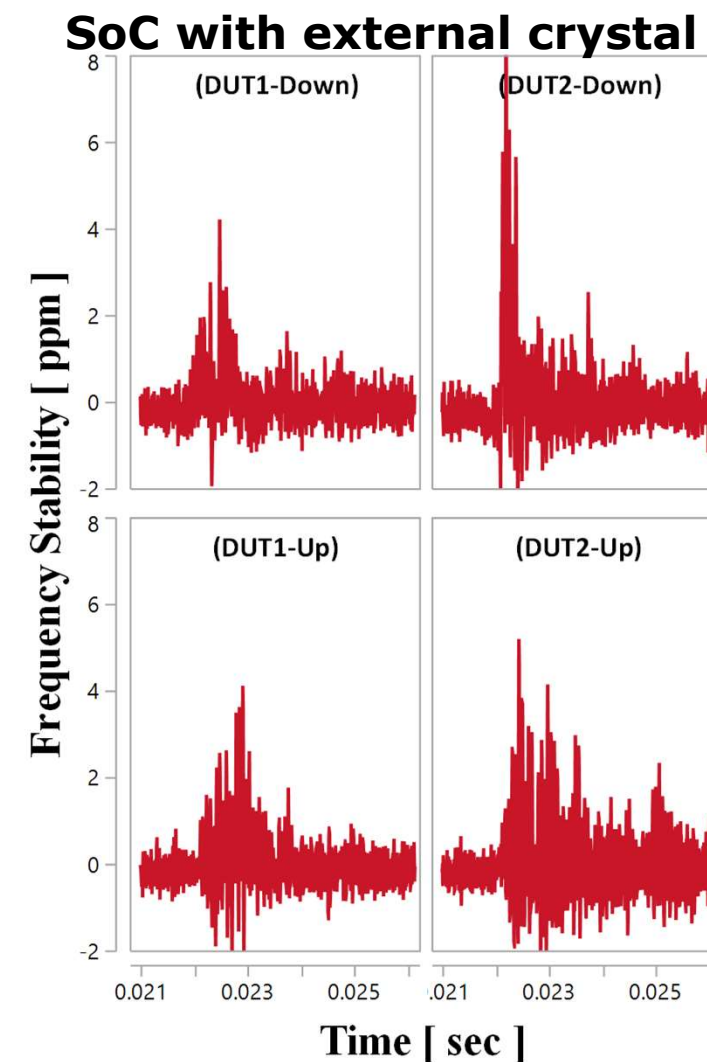
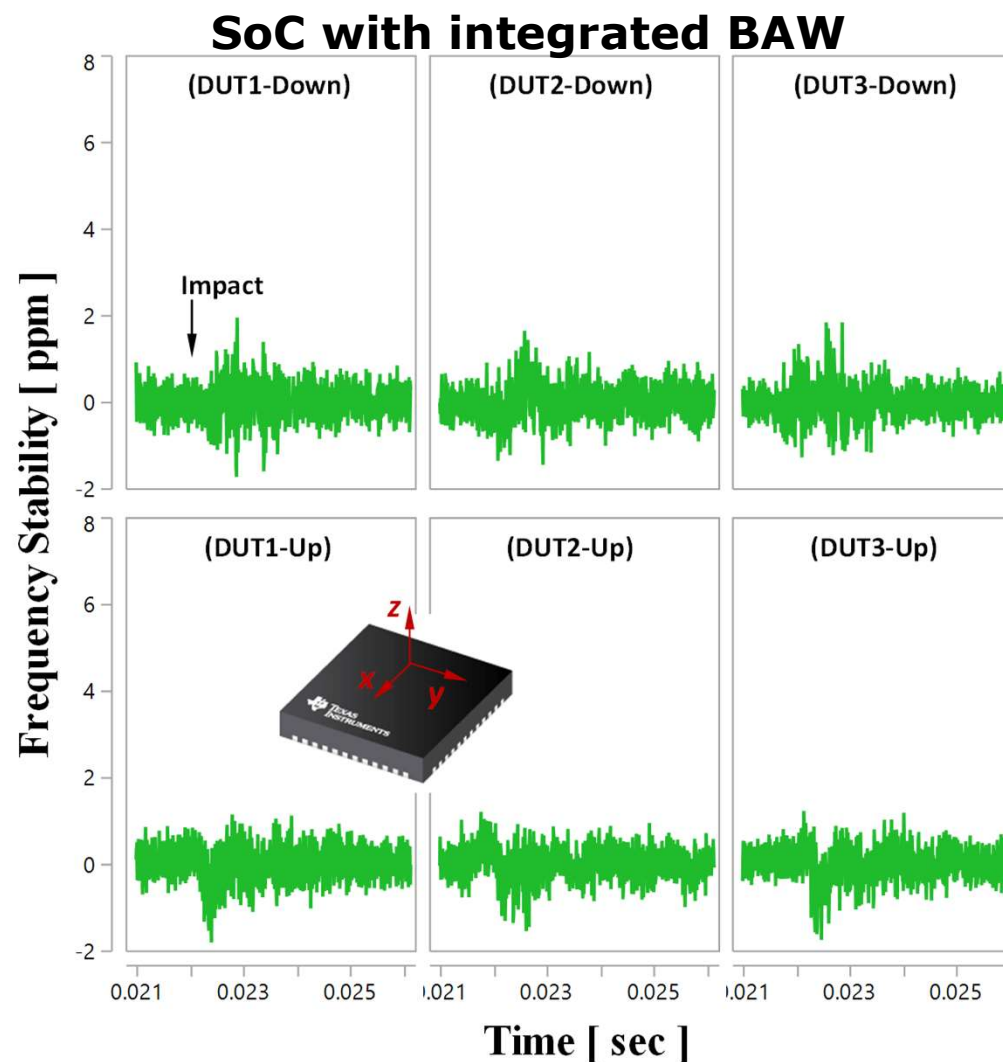
Mechanical Shock

TEST	STANDARD	METHOD	DESCRIPTION
Mechanical Shock	MIL-STD-883H (QSS 009-119)	2002.5, Level B	Acceleration peak 1,500g Pulse duration 0.5ms 3 perpendicular axes (x, y, z) 5 shocks



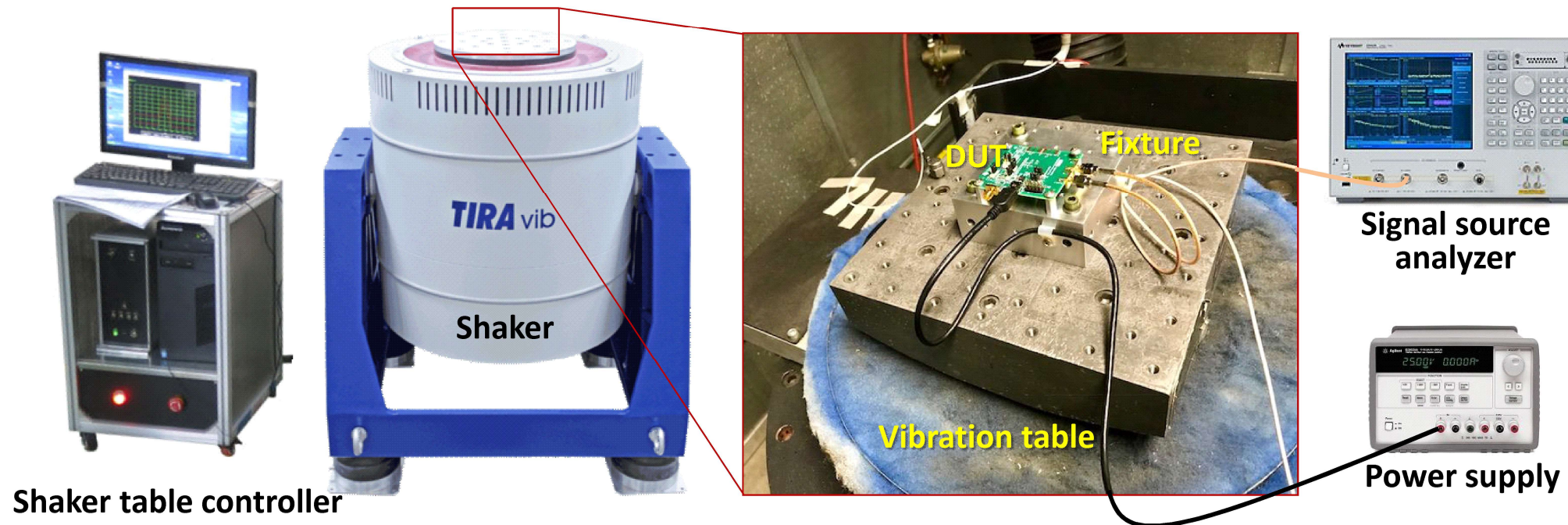
Measured Results - Shock

- SoC frequency measured with both integrated BAW and external crystal
- SoC with integrated BAW shows 4x better shock immunity than with external crystal
 - 1-2ppm vs. 4-8ppm
- BAW resonator less effected by shock than crystal due to lower mass



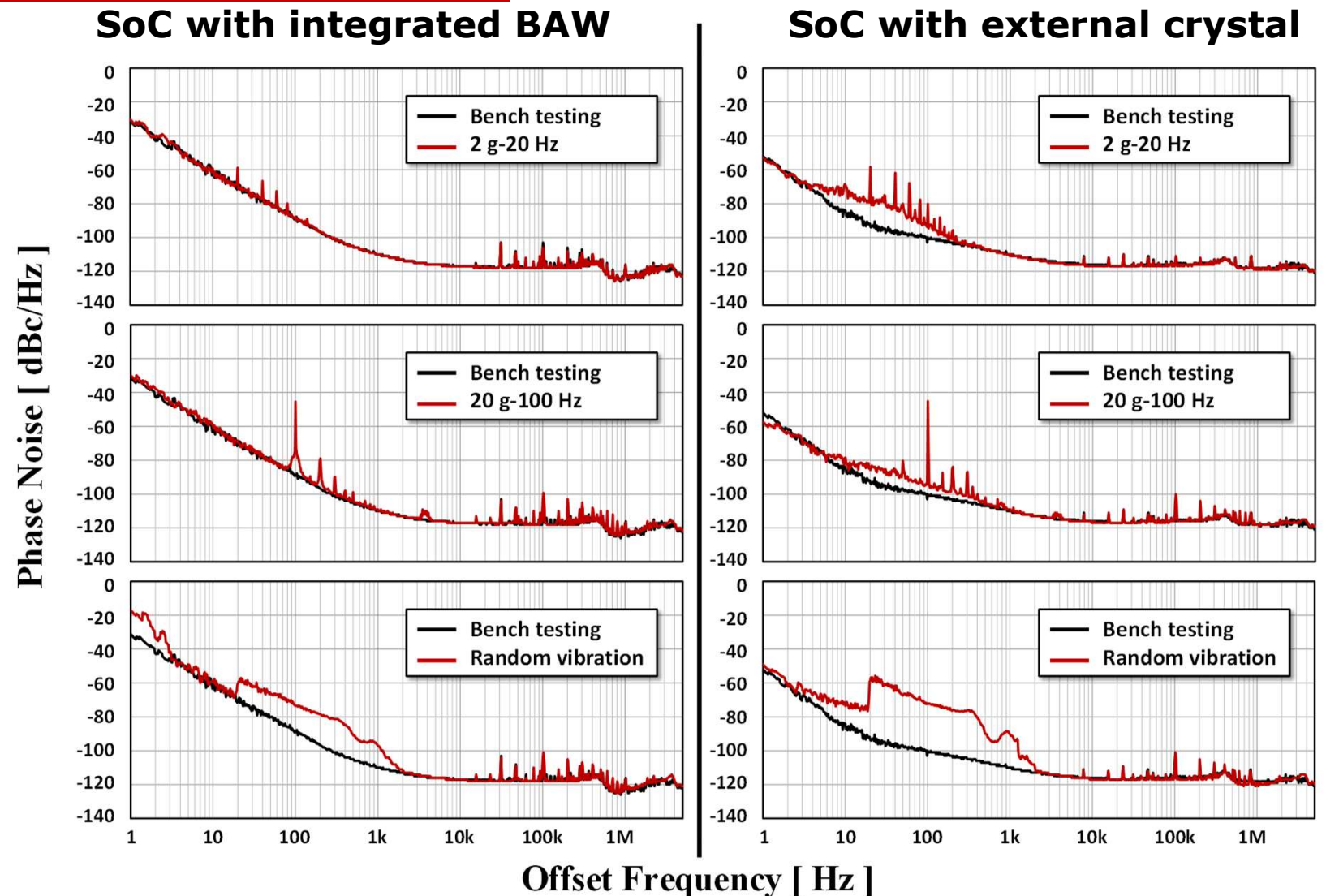
Vibration

TEST	STANDARD	METHOD	DESCRIPTION
Sinusoidal Vibration	MIL-STD-202G	204D, Condition C/D	Amplitude: 1.5 mm 4-g /10-g peak acceleration Freq: 20 to 2,000 Hz 20 minutes 3 perpendicular axes (x, y, z)
Random Vibration	MIL-STD-883H	2026, Condition B/E	Power spectrum density: 0.04 Overall RMS acceleration: 7.3-g 3 perpendicular axes (x, y, z)



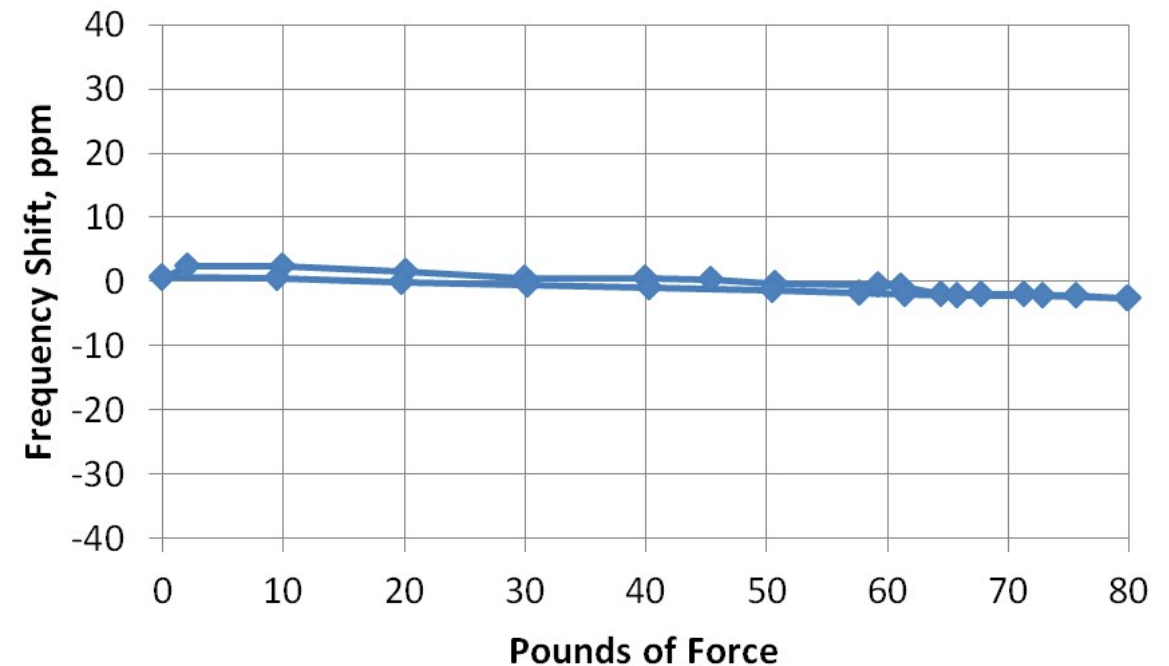
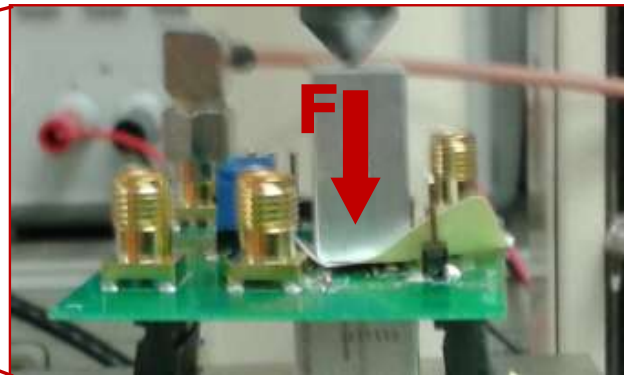
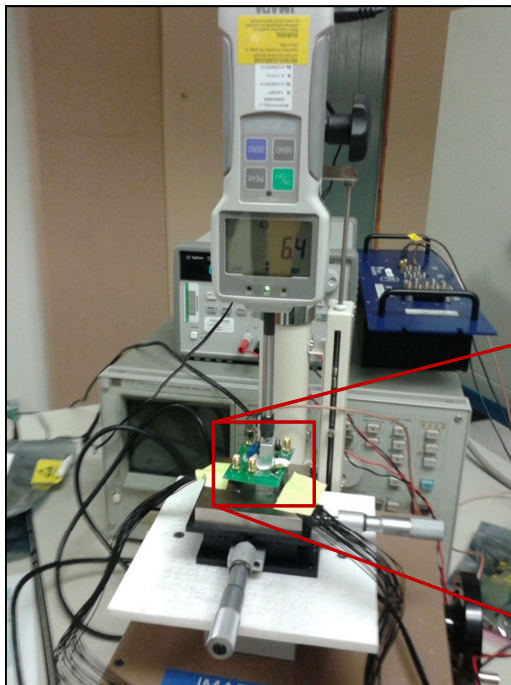
Measured Results - Vibration

- Phase noise on the SoC's 48MHz clock measured in the presence of sinusoidal and random vibration
- Similar increase in noise and spurs for BAW and crystal oscillator clock source
- Performance limited by spurious resonance modes of PCB

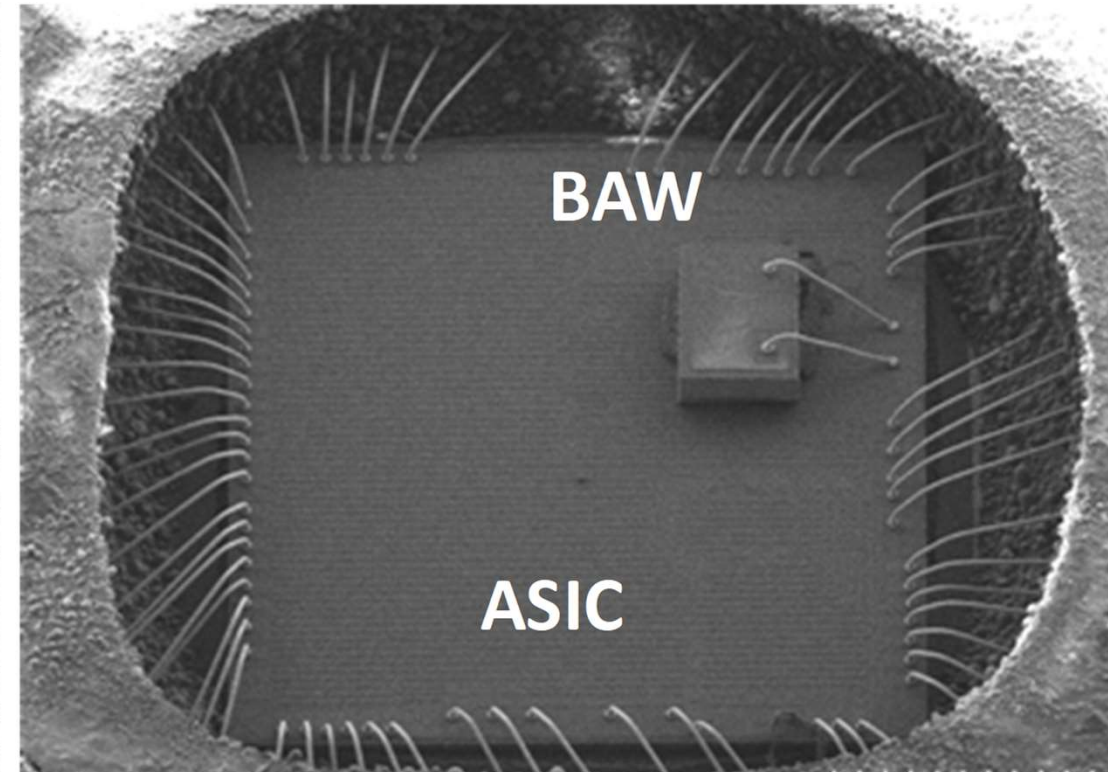
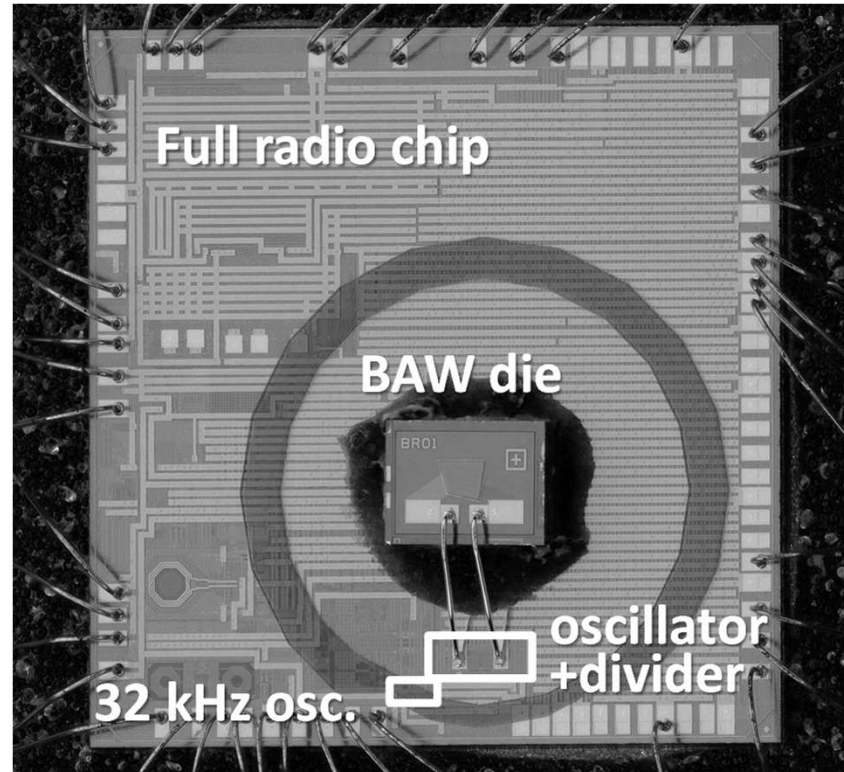
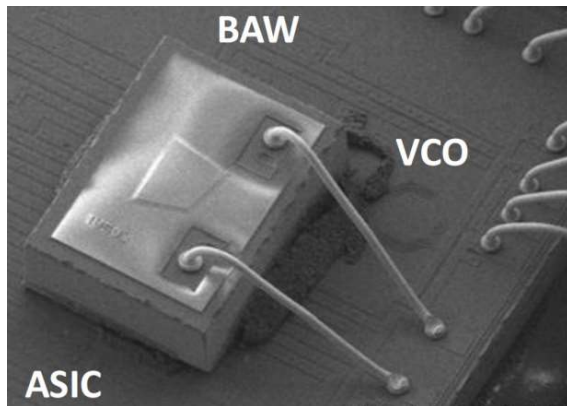
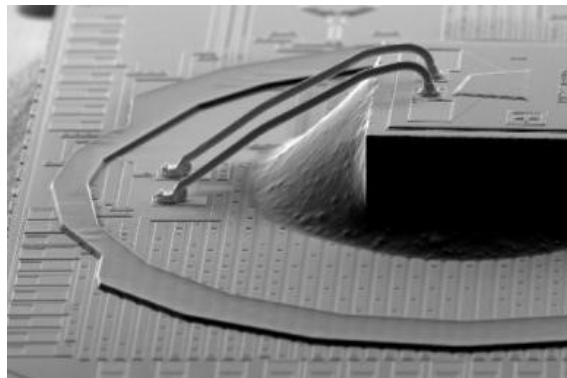


Stress Sensitivity

- Oscillator frequency shift measured as a function of pressure placed on top of the package.
 - Shift <2ppm up to 80lb force, slight hysteresis
- Average frequency shift caused by changes in package stress from soldering are small and included in the frequency compensation parameters



Die and Packaging Photos



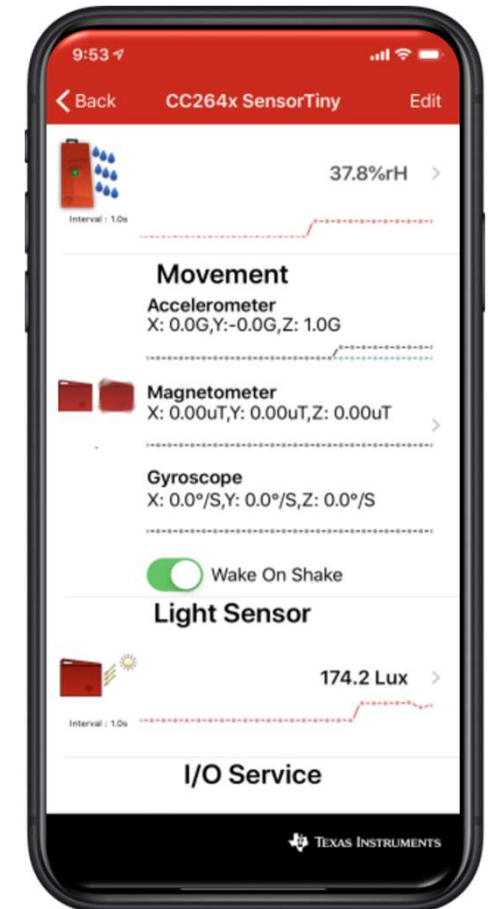
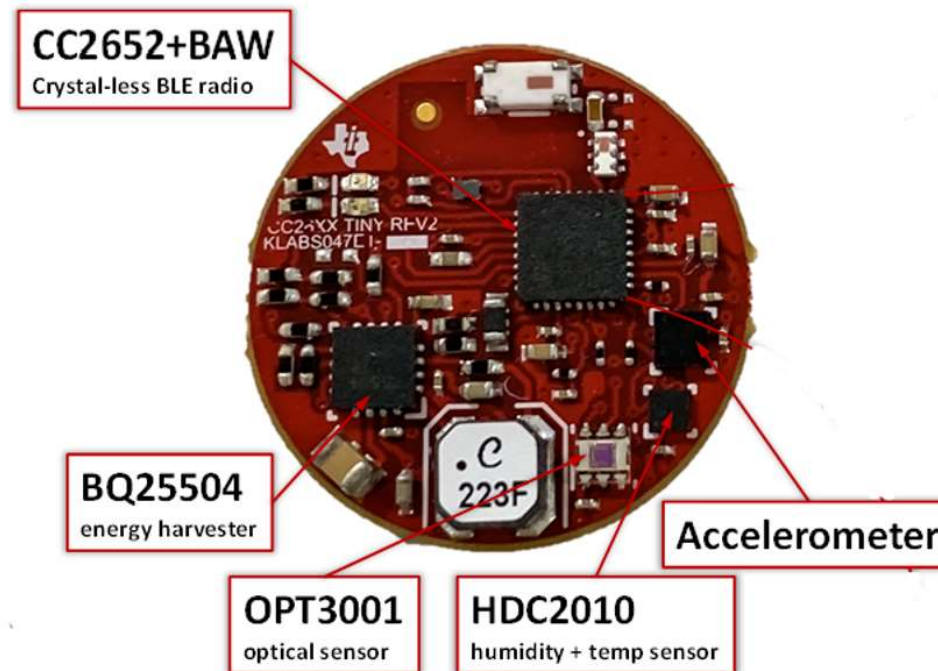
□ Side views of BAW resonators wire-bonded to the active circuitry below.

□ Top view of BAW resonator used in a BLE radio packaged in a 4x4 QFN plastic package.

□ BAW resonator used with an ASIC in a 7x7 QFN.

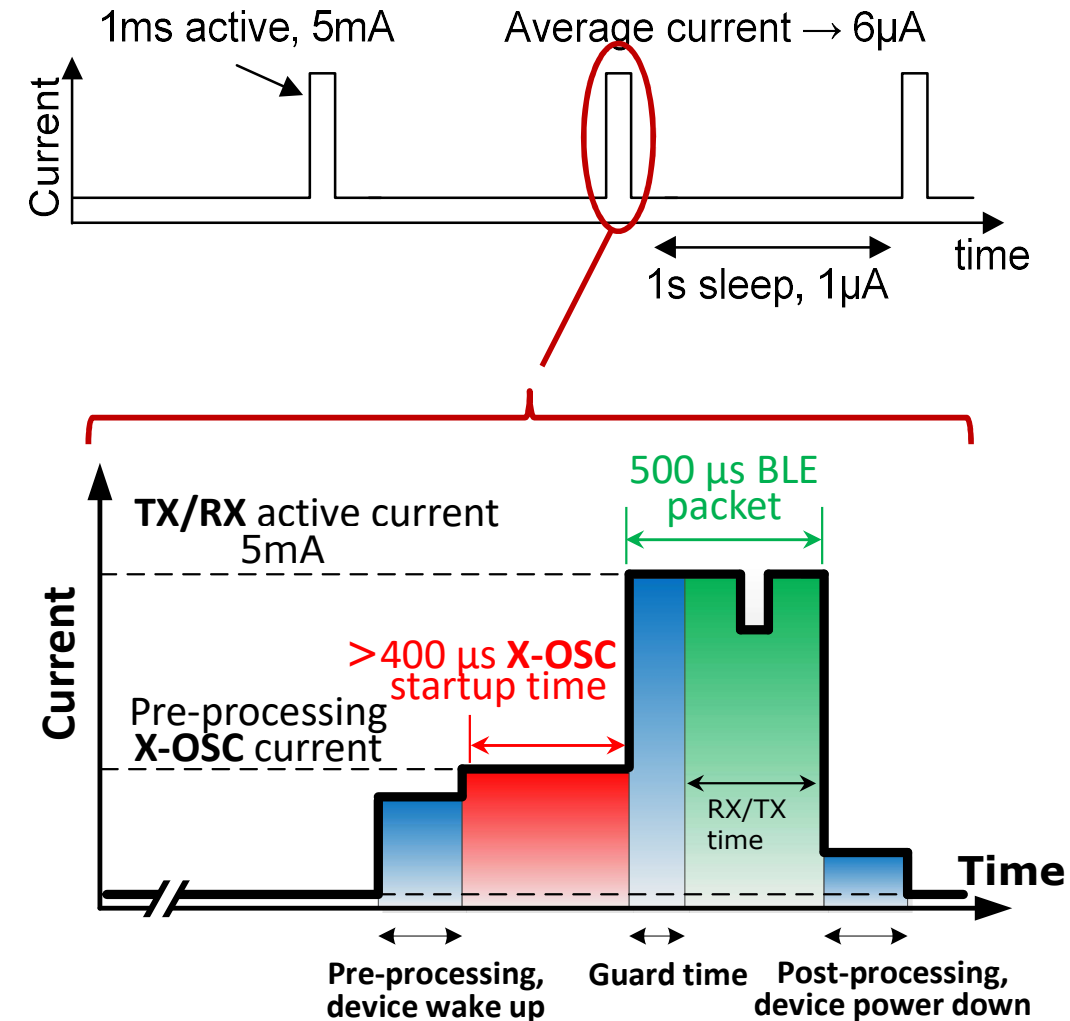
Smaller Footprint

- ❑ Space saved by removing crystal allows more sensors to be used in the same footprint
- ❑ Enables applications with limited space, harsh, vibration-rich environments such as power tools and factory automation



Duty-Cycled Wireless Systems

- ❑ Data throughput requirements are low in many IoT applications
- ❑ Aggressively duty cycle ratio to reduce average power
- ❑ Radio active only $\sim 0.01\%$ to 1% of the time, rest of the time in low power sleep state
- ❑ Accurate MHz crystal oscillator needed for RF generation
- ❑ Crystal oscillator startup time can be long compared to typical data packet
- ❑ Significant fraction of energy for each RX/TX burst is used to turn on the oscillator

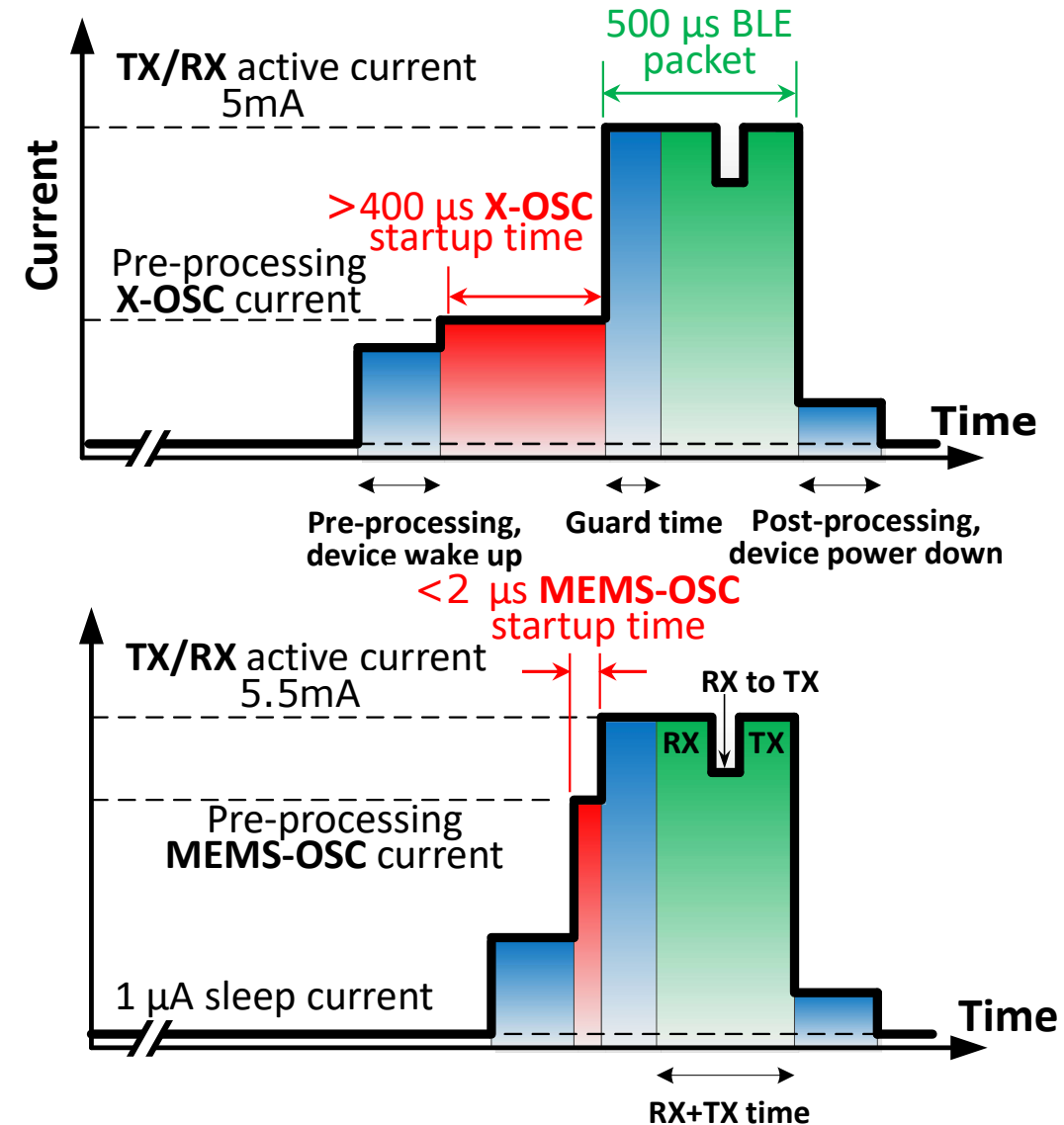


BAW Fast Start Advantage

- BAW oscillator starts faster than a typical MHz crystal oscillator due to $\sim 10\times$ lower Q & $100\times$ higher frequency

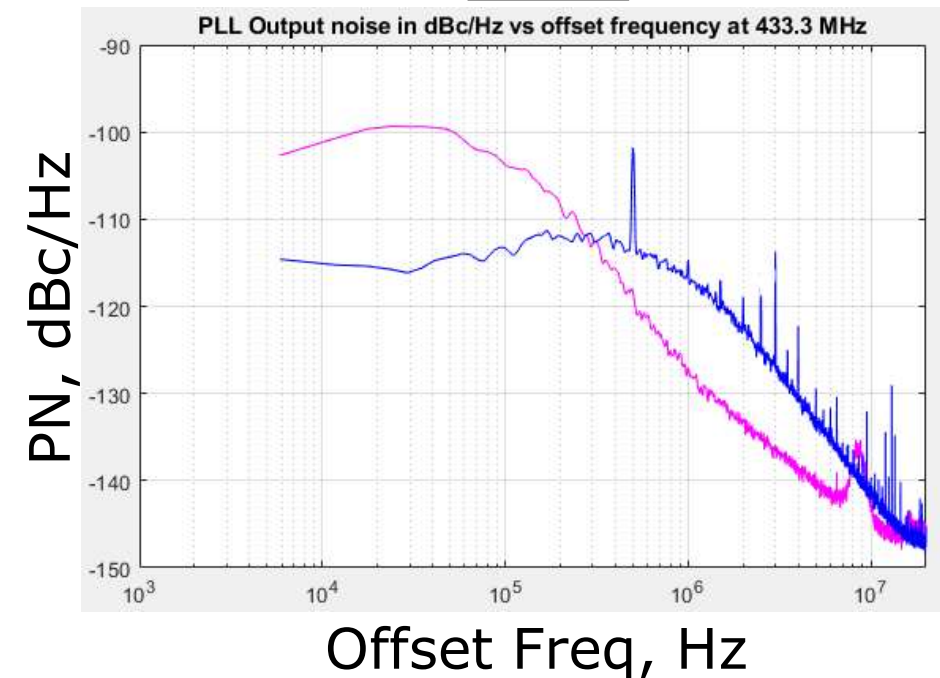
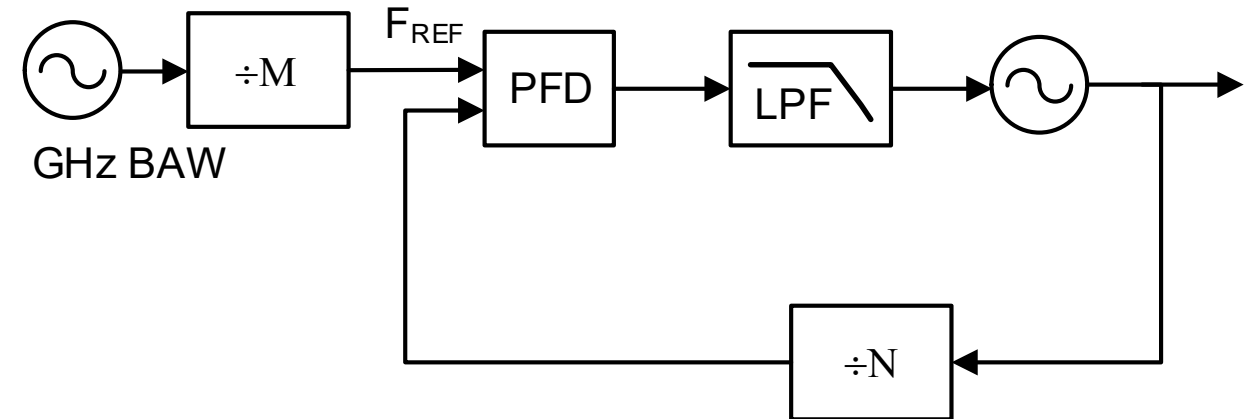
$$t_{start} \propto \frac{Q}{f}$$

- BAW oscillator + divider current is higher than crystal oscillator current, but average system power can be lower due to fast startup.
- BAW oscillator can give net energy savings for short data packets



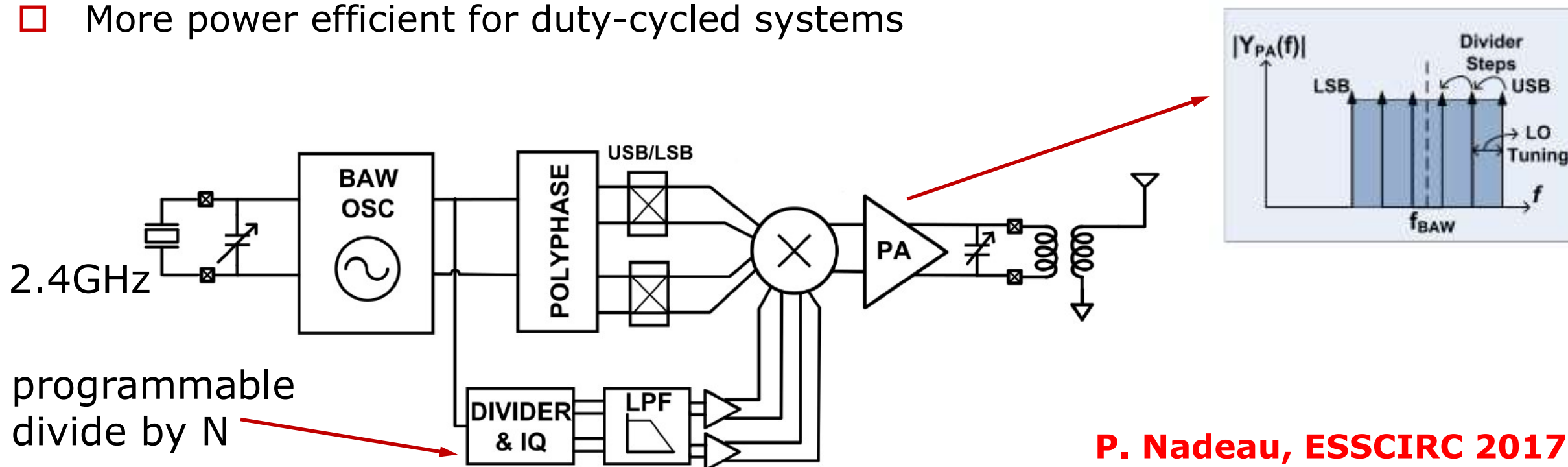
Higher Frequency Reference Clock

- Traditional WiFi/Bluetooth products use <60MHz crystal oscillators as reference clock for RF synthesizer
- Newer generations of WiFi can improve RF synthesizer phase noise by using >60MHz reference clock
 - Higher loop bandwidth possible
 - Lower N, lower noise from PFD
 - Optimize F_{REF} based on performance, not crystal availability
- Can also save cost
 - >60MHz crystals are expensive



Multi-Channel ISM Band TX with no PLL

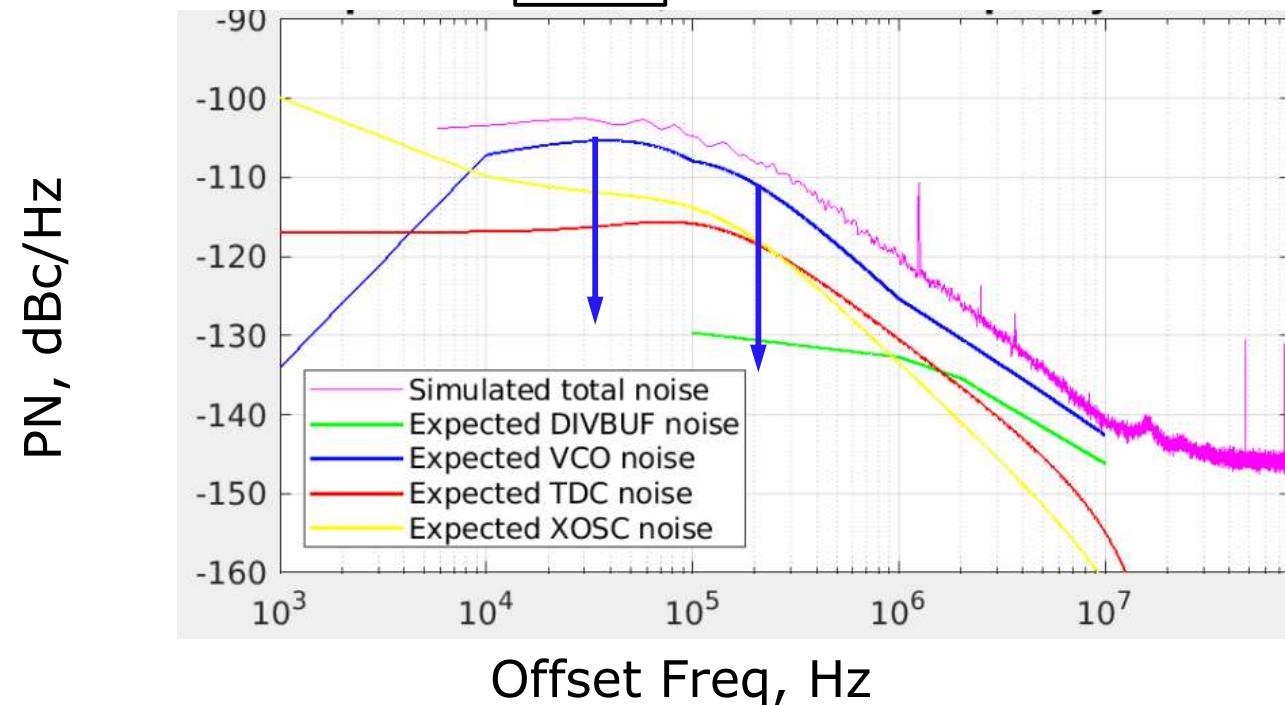
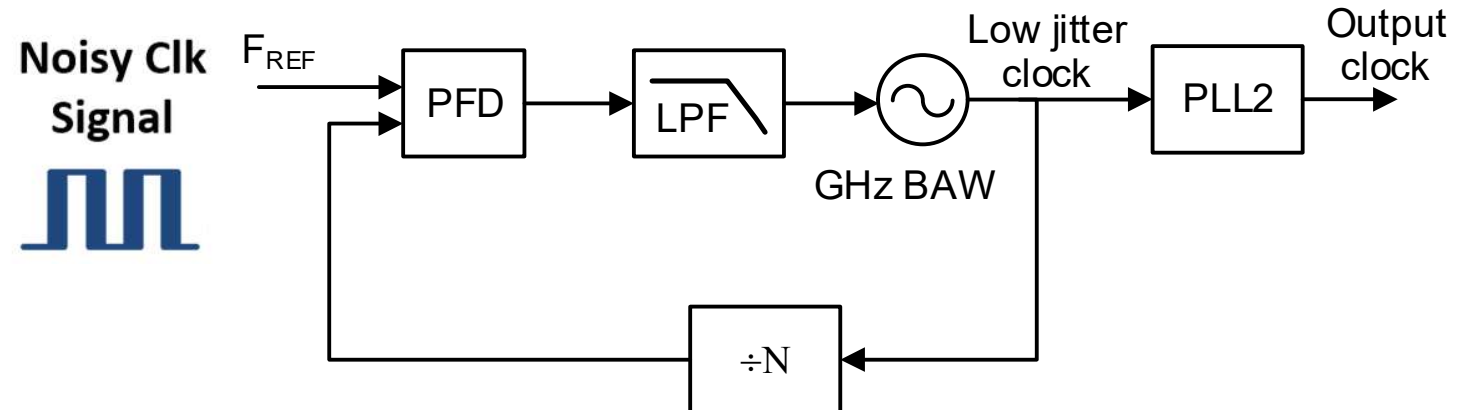
- Frequency plan covers full 2.4GHz ISM band (80MHz, 3.3%) with no PLL or fractional dividers
 - Even though BAW tuning range is <1%
- 2.3 μ s start-up time: Avoid slow startup time of crystal, RF synth lock time
- More power efficient for duty-cycled systems



P. Nadeau, ESSCIRC 2017

Jitter Cleaning

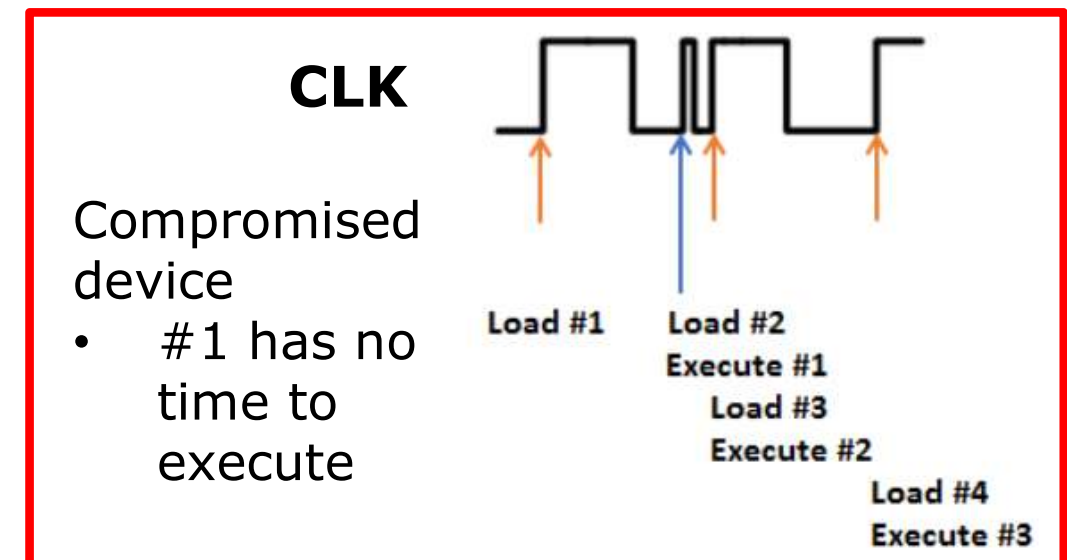
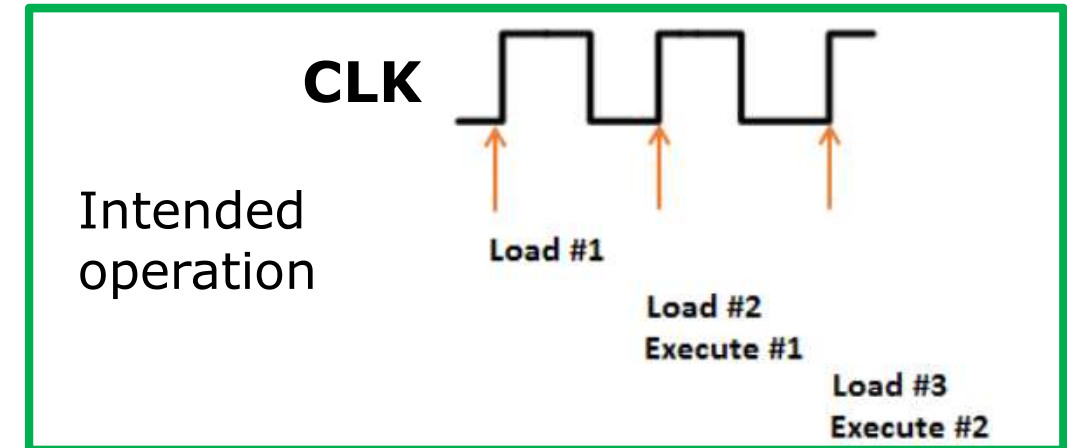
- 2 series connected PLLs to generate high frequency, low phase noise output clock
 - First PLL cleans reference jitter
 - Second generates high frequency output
- Replacing VCO in first PLL with BAW oscillator allows lower clock jitter
 - Noise outside of loop bandwidth dominated by VCO/BAW
 - High freq + high Q of BAW oscillator reduces jitter



Offset Freq, Hz

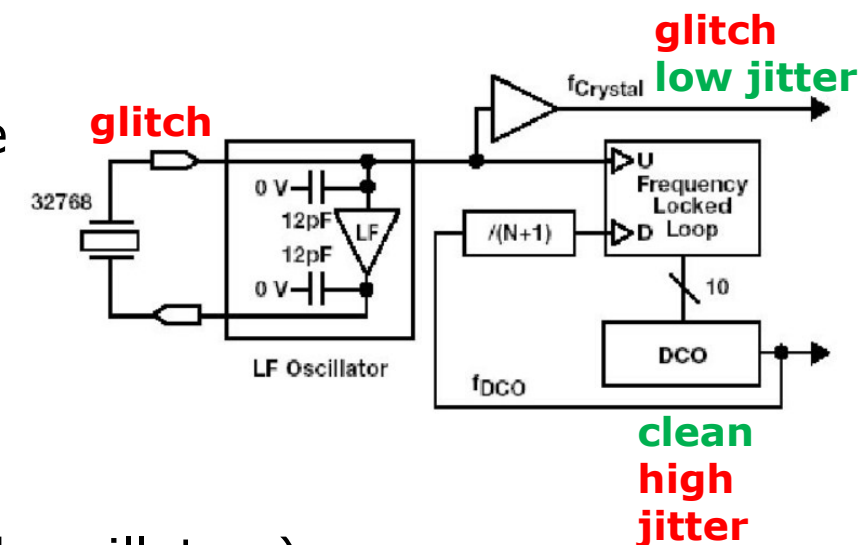
Bypass Security through XO

- ❑ Security usually brings to mind data encryption requirements
- ❑ But encryption can be bypassed through glitching the clock, causing instructions to be skipped.
 - If skipped instruction is password check or encryption step, device security is bypassed
 - Search for «chipwhisperer» for a tutorial
- ❑ Device security is no stronger than the security in the clock system!
- ❑ Solution: Fully integrated clock sources



Clock System Security

- Solution 1: Filter glitches on crystal oscillator output
 - Typical flexible MHz oscillator is 4-80MHz – a glitch at 4MHz is the entire clock cycle at 80MHz.
 - *Only a partial solution*
- Solution 2: Frequency lock integrated oscillator to crystal oscillator
 - Glitches filtered out at the output of the integrated oscillator
 - Use only clock from integrated oscillator where possible
 - But some circuits must use crystal oscillator for noise/jitter reasons
 - Example: radio transmission could be disrupted
 - *Only a partial solution*
- Solution 3: No external pins for crystals
 - Must use only internal clock sources (BAW + integrated oscillators)
 - *Most robust solution* - no glitches without decapping chip, which can be detected



Conclusions

- Bulk Acoustic Wave resonators are an advancement over 100 year-old crystal technology
- With active and passive temperature compensation, BAW resonators enable
 - Reduced size and cost
 - Improved frequency stability at temperature extremes
 - Robustness to shock and vibration
 - Fast start up for power reduction in duty-cycled systems
 - Flexibility in reference clock frequency choice for RF synthesizers
 - Advancements in clock jitter cleaner performance
 - Improved security with fully integrated clock systems

References

- A. Schaer, "Behavior and Current Performance of SAW and BAW Oscillators," IEEE European Microwave Conf., pp. 249-253, 1976.
- J. Chabloz, et. al, "Frequency synthesis for a low-power 2.4 GHz receiver using a BAW oscillator and a relaxation oscillator," IEEE European Solid-State Circuits Conference Proceedings, pp. 492-495, 2007.
- K. Wang, et al, "A 1.8mW PLL-free channelized 2.4GHz ZigBee receiver utilizing fixed-LO temperature-compensated FBAR resonator," IEEE International Solid-State Circuits Conference Digest of Tech. Papers, pp. 372-373, Feb. 2014.
- B. Jakoby, et al, "The Potential of Microacoustic SAW and BAW-Based Sensors for Automotive Applications – A Review," IEEE Sensors Journal, Vol. 2, No. 5, Oct. 2002.
- E. Courjon, et al, "High overtone bulk acoustic resonators for high temperature sensing applications," IEEE Joint European Frequency and Time Forum & International Frequency Control Symposium, pp. 992-995, 2013.
- D. Ruffieux, et al, "A Narrowband Multi-Channel 2.4 GHz MEMS-Based Transceiver," IEEE Journal of Solid-State Circuits, Vol. 44, No. 1, Jan. 2009.
- D. Petit, et. al, "Temperature Compensated BAW Resonator and its integrated Thermistor for a 2.5GHz Electrical Thermally Compensated Oscillator," IEEE Radio Frequency Integrated Circuits Symposium, pp. 339-342, 2009.
- M. Heidarpour, et al, "A MEMS-Assisted Temperature Sensor With 20- μ K Resolution, Conversion Rate of 200 S/s, and FOM of 0.04 pJK²," IEEE Journal of Solid-State Circuits, Vol. 52, No. 1, pp. 185-197, 2017.
- S. Gilbert, et. al, "Manufacturing and Reliability of Chip-Scale Packaged FBAR Oscillators," IEEE International Ultrasonics Symposium, pp. 89-92, 2014.

References

- R. Thirunarayanan, et al., "Reducing energy dissipation in ULP systems: PLL-free FBAR-based fast startup transmitters," IEEE Trans. on Microwave Theory and Techniques, vol. 63, pp. 1100-1117, April 2015.
- N. Sinoussi, et al., "A single LC tank self-compensated CMOS oscillator with frequency stability of ± 100 ppm from -40°C to 85°C ," IEEE Int. Freq. Control Symp., May 2012.
- S. Sridaran, et al., "Low jitter FBAR based chip scale precision oscillator", IEEE Int. Ultrasonics Symp, pp. 85-88, Sept. 2014.
- K. Sankaragomathi, et al., "A ± 3 ppm 1.1mW FBAR frequency reference with 750MHz output and 750mV supply" IEEE J. Solid State Circuits, pp. 454-455, 2015.
- R. Thirunarayanan, et al., "Complementary BAW oscillator for ultra-low power consumption and low phase noise," IEEE New Circuits and Systems Conf, pp. 97-100, June 2011.
- D. Griffith, et. al, "An Integrated BAW Oscillator with $< \pm 30$ ppm Frequency Stability over Temperature, Package Stress, and Aging Suitable for High-volume Production," IEEE International Solid State Circuits Conference, Feb. 2020
- E. Yen, et. al, "Integrated High-Frequency Reference Clock Systems Utilizing Mirror-Encapsulated BAW Resonators," IEEE International Ultrasonics Symposium, October 2019
- D. Griffith, et. al, "A ± 10 ppm -40 to 125°C BAW-Based Frequency Reference System for Crystal-less Wireless Sensor Nodes," IEEE Symposium on Circuits and Systems, 29 May, 2017.
- P. Nadeau, et. al, "Single-BAW multi-channel transmitter with low power and fast start-up time" ESSCIRC 2017.